



OET 65

TEST REPORT

Product Name	HSPA+ USB Stick
Model	MF660
FCC ID	Q78-ZTEMF660
Client	ZTE CORPORATION

TA Technology (Shanghai) Co., Ltd.

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1110-1724SAR01R1

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GENERAL SUMMARY

Product Name	HSPA+ USB Stick	Model	MF660
FCC ID	Q78-ZTEMF660		
Report No.	RZA1110-1724SAR01R1		
Client	ZTE CORPORATION		
Manufacturer	ZTE CORPORATION		
Reference Standard(s)	<p>IEEE Std C95.1, 1999: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.</p> <p>SUPPLEMENT C Edition 01-01 to OET BULLETIN 65 Edition 97-01 June 2001 including DA 02-1438, published June 2002: Evaluating Compliance with FCC Guidelines for Human Exposure to Radio frequency Electromagnetic Fields Additional Information for Evaluation Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radio frequency Emissions.</p> <p>KDB 447498 D02 SAR Procedures for Dongle Xmtr v02: SAR Measurement Procedures for USB Dongle Transmitters.</p>		
Conclusion	<p>This portable wireless equipment has been measured in all cases requested by the relevant standards. Test results in Chapter 7 of this test report are below limits specified in the relevant standards.</p> <p>General Judgment: Pass</p> <p style="text-align: right;">(Stamp) Date of issue: November 9th, 2011</p>		
Comment	The test result only responds to the measured sample.		

Approved by 初伟中
Director

Revised by 凌敏宝
SAR Manager

Performed by 秦川
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1. General Information

1.1. Notes of the Test Report

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone does not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

If the electrical report is inconsistent with the printed one, it should be subject to the latter.

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1.3. Applicant Information

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1.5. Information of EUT

General Information

Device Type:	Portable Device		
Exposure Category:	Uncontrolled Environment / General Population		
State of Sample:	Prototype Unit		
Product Name:	HSPA+ USB Stick		
IMEI:	356722040009135		
Hardware Version:	dk6A		
Software Version:	EN_ZTE_MF660V1.0.0B04		
Antenna Type:	Internal Antenna		
Device Operating Configurations:			
Supporting Mode(s):	WCDMA Band II/ WCDMA Band V; (tested) GSM 850/ GSM 1900/ GSM 900/ GSM 1800; (untested) WCDMA Band I; (untested)		
Test Modulation:	(WCDMA) QPSK		
Device Class:	B		
HSDPA UE Category:	14		
HSUPA UE Category:	6		
Power Class:	WCDMA Band II: 3, tested with power control all up bits		
	WCDMA Band V: 3, tested with power control all up bits		
Test Channel: (Low - Middle - High)	9262 - 9400 - 9538	(WCDMA Band II) (tested)	
	4132 - 4183 - 4233	(WCDMA Band V) (tested)	
Operating Frequency Range(s):	Mode	Tx (MHz)	Rx (MHz)
	WCDMA Band II	1852.4 ~ 1907.6	1932.4 ~ 1987.6
	WCDMA Band V	826.4 ~ 846.6	871.4 ~ 891.6
Used Host Products:	IBM T61		
	Lenovo Y-450		

Equipment Under Test (EUT) is a HSPA+ USB Stick. The EUT has a GSM/WCDMA antenna that is used for Tx/Rx. During SAR test of the EUT, it was connected to a portable computer. SAR is tested for the EUT respectively for WCDMA Band II and WCDMA Band V in this report.

The sample undergoing test was selected by the Client.

Components list please refer to documents of the manufacturer.

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1.6. The Maximum SAR_{1g} Values of Each Tested Mode

Mode	Channel	Position	Distance(mm)	SAR_{1g} (W/kg)
WCDMA Band II	Low/9262	Test Position 2	5	1.050
WCDMA Band V	Low/4132	Test Position 1	5	0.590

1.7. The Maximum Conducted Power of Each Tested Mode

Mode	Maximum Conducted Power (dBm)
WCDMA Band II	22.88
WCDMA Band V	22.70

Note: The detail Power refers to Table 9 (Conducted Power Measurement Results).

1.8. Test Date

The test is performed on October 13, 2011.

2. Operational Conditions during Test

2.1. General Description of Test Procedures

Connection to the EUT is established via air interface with E5515C, and the EUT is set to maximum output power by E5515C. Using E5515C the power control is set “All Up Bits” of WCDMA. The antenna connected to the output of the base station simulator shall be placed at least 50 cm away from the EUT. The signal transmitted by the simulator to the antenna feeding point shall be lower than the output power level of the EUT by at least 30 dB.

The measurements were performed in combination with two host products (IBM T61 and Lenovo Y-450). IBM T61 laptop has horizontal USB slot, Lenovo Y-450 laptop has vertical USB slot.

2.2. WCDMA Test Configuration

As the SAR body tests for WCDMA Band II and WCDMA Band V, we established the radio link through call processing. The maximum output power were verified on high, middle and low channels for each test band according to 3GPP TS 34.121 with the following configuration:

- 1) 12.2kbps RMC, 64,144,384 kbps RMC with TPC set to all “all ‘1’s”
- 2) Test loop Mode 1

For the output power, the configurations for the DPCCH and DPDCH₁ are as followed (EUT do not support the DPDCH_{2-n})

Table 1: The configurations for the DPCCH and DPDCH₁

	Channel Bit Rate(kbps)	Channel Symbol Rate(kps)	Spreading Factor	Spreading Code Number	Bits/Slot
DPCCH	15	15	256	0	10
DPDCH ₁	15	15	256	64	10
	30	30	128	32	20
	60	60	64	16	40
	120	120	32	8	80
	240	240	16	4	160
	480	480	8	2	320
	960	960	4	1	640

SAR is tested with 12.2kps RMC and not required for other spreading codes (64,144, and 384 kbps RMC) and multiple DPDCH_n, because the maximum output power for each of these other configurations<0.25dB higher than 12.2kbps RMC and the multiple DPDCH_n is not applicable for the EUT.

2.3. HSDPA Test Configuration

SAR for body exposure configurations is measured according to the “Body SAR Measurements” procedures of 3G device. In addition, body SAR is also measured for HSDPA when the maximum average output of each RF channel with HSDPA active is at least 1/4 dB higher than that measured without HSDPA using 12.2kbps RMC or the maximum SAR 12.2kbps RMC is above 75% of the SAR limit. Body SAR for HSDPA is measured using an FRC with H-Set 1 in Sub-test 1 and a 12.2kbps RMC configured in Test Loop Mode 1, using the highest body SAR configuration in 12.2 kbps RMC without HSDPA.

HSDPA should be configured according to the UE category of a test device. The number of HS-DSCH/HS-PDSCHs, HARQ processes, minimum inter-TTI interval, transport block sizes and RV coding sequence are defined by the H-set. To maintain a consistent test configuration and stable transmission condition, QPSK is used in the H-set for SAR testing. HS-DPCCH should be configured with a CQI feedback cycle of 4 ms with a CQI repetition factor of 2 to maintain a constant rate of active CQI slots. DPCCH and DPDCH gain factors(β_c, β_d), and HS-DPCCH power offset parameters(Δ_{ACK} , Δ_{NACK} , Δ_{CQI}) should be set according to values indicated in the Table below. The CQI value is determined by the UE category, transport block size, number of HS-PDSCHs and modulation used in the H-set.

Table 2: Subtests for UMTS Release 5 HSDPA

Sub-set	β_c	β_d	β_d (SF)	β_c/β_d	β_{hs} (note 1, note 2)	CM(dB) (note 3)	MPR(dB)
1	2/15	15/15	64	2/15	4/15	0.0	0.0
2	12/15 (note 4)	15/15 (note 4)	64	12/15 (note 4)	24/15	1.0	0.0
3	15/15	8/15	64	15/8	30/15	1.5	0.5
4	15/15	4/15	64	15/4	30/15	1.5	0.5

Note1: Δ_{ACK} , Δ_{NACK} and $\Delta_{CQI} = 8 \Leftrightarrow A_{hs} = \beta_{hs}/\beta_c = 30/15 \Leftrightarrow \beta_{hs} = 30/15 * \beta_c$

Note2: For the HS-DPCCH power mask requirement test in clause 5.2C, 5.7A, and the Error Vector Magnitude (EVM) with HS-DPCCH test in clause 5.13.1.A, and HSDPA EVM with phase discontinuity in clause 5.13.1AA, Δ_{ACK} and $\Delta_{NACK} = 8$ ($A_{hs} = 30/15$) with $\beta_{hs} = 30/15 * \beta_c$, and $\Delta_{CQI} = 7$ ($A_{hs} = 24/15$) with $\beta_{hs} = 24/15 * \beta_c$.

Note3: CM=1 for $\beta_c/\beta_d = 12/15$, $\beta_{hs}/\beta_c = 24/15$. For all other combinations of DPDCH, DPCCH and HS-DPCCH the MPR is based on the relative CM difference. This is applicable for only UEs that support HSDPA in release 6 and later releases.

Note 4: For subtest 2 the β_c/β_d ratio of 12/15 for the TFC during the measurement period (TF1, TF0) is achieved by setting the signaled gain factors for the reference TFC (TFC1, TF1) to $\beta_c = 11/15$ and $\beta_d = 15/15$.

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Table 3: Settings of required H-Set 1 QPSK in HSDPA mode

Parameter	Unit	Value
Nominal Avg. Inf. Bit Rate	kbps	534
Inter-TTI Distance	TTI's	3
Number of HARQ Processes	Processes	2
Information Bit Payload (N_{INF})	Bits	3202
Number Code Blocks	Blocks	1
Binary Channel Bits Per TTI	Bits	4800
Total Available SML's in UE	SML's	19200
Number of SML's per HARQ Proc.	SML's	9600
Coding Rate	/	0.67
Number of Physical Channel Codes	Codes	5
Modulation	/	QPSK

Table 4: HSDPA UE category

HS-DSCH Category	Maximum HS-DSCH Codes Received	Minimum Inter-TTI Interval	Maximum Transport Bits/HS-DSCH	Total Channel
1	5	3	7298	19200
2	5	3	7298	28800
3	5	2	7298	28800
4	5	2	7298	38400
5	5	1	7298	57600
6	5	1	7298	67200
7	10	1	14411	115200
8	10	1	14411	134400
9	15	1	25251	172800
10	15	1	27952	172800
11	5	2	3630	14400
12	5	1	3630	28800
13	15	1	34800	259200
14	15	1	42196	259200
15	15	1	23370	345600
16	15	1	27952	345600

2.4. HSUPA Test Configuration

Body SAR is also measured for HSPA when the maximum average output of each RF channel with HSPA active is at least ¼ dB higher than that measured without HSPA using 12.2 kbps RMC or the maximum SAR for 12.2 kbps RMC is above 75% of the SAR limit. Body SAR for HSPA is measured with E-DCH Sub-test 5, using H-Set 1 and QPSK for FRC and a 12.2 kbps RMC configured in Test Loop Mode 1 with power control algorithm 2, according to the highest body SAR configuration in 12.2 kbps RMC without HSPA.⁴⁰

Due to inner loop power control requirements in HSPA, a commercial communication test set should be used for the output power and SAR tests.⁴¹ The 12.2 kbps RMC, FRC H-set 1 and E-DCH configurations for HSPA should be configured according to the β values indicated below as well as other applicable procedures described in the 'WCDMA Handset' and 'Release 5 HSDPA Data Devices' sections of 3 G device.

Table 5: Sub-Test 5 Setup for Release 6 HSUPA

Sub-test	β_c	β_d	β_d (SF)	β_c/β_d	β_{HS} (Note 1)	β_{ec}	β_{ed} (Note 4) (Note 5)	β_{ed} (SF)	β_{ed} (Codes)	CM (dB) (Note 2)	MPR (dB) (Note 2) (Note 6)	AG Index (Note 5)	E- TFCI
1	11/15 (Note 3)	15/15 (Note 3)	64	11/15 (Note 3)	22/15	209/25	1309/225	4	1	1.0	0.0	20	75
2	6/15	15/15	64	6/15	12/15	12/15	94/75	4	1	3.0	2.0	12	67
3	15/15	9/15	64	15/9	30/15	30/15	β_{ed1} : 47/15 β_{ed2} : 47/15	4 4	2	2.0	1.0	15	92
4	2/15	15/15	64	2/15	4/15	2/15	56/75	4	1	3.0	2.0	17	71
5	15/15	0	-	-	5/15	5/15	47/15	4	1	1.0	0.0	12	67

Note 1: For sub-test 1 to 4, Δ_{ACK} , Δ_{NACK} and $\Delta_{CQI} = 30/15$ with $\beta_{hs} = 30/15 * \beta_c$. For sub-test 5, Δ_{ACK} , Δ_{NACK} and $\Delta_{CQI} = 5/15$ with $\beta_{hs} = 5/15 * \beta_c$.

Note 2: CM = 1 for $\beta_c/\beta_d = 12/15$, $\beta_{hs}/\beta_c = 24/15$. For all other combinations of DPDCH, DPCCH, HS-DPCCH, E-DPDCH and E-DPCCH the MPR is based on the relative CM difference.

Note 3: For subtest 1 the β_c/β_d ratio of 11/15 for the TFC during the measurement period (TF1, TF0) is achieved by setting the signalled gain factors for the reference TFC (TF1, TF1) to $\beta_c = 10/15$ and $\beta_d = 15/15$.

Note 4: In case of testing by UE using E-DPDCH Physical Layer category 1, Sub-test 3 is omitted according to TS25.306 Table 5.1g.

Note 5: β_{ed} can not be set directly; it is set by Absolute Grant Value.

Note 6: For subtests 2, 3 and 4, UE may perform E-DPDCH power scaling at max power which could results in slightly smaller MPR values.

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Table 6: HSUPA UE category

E-DCH category	Maximum number of E-DCH codes transmitted per transport block	Minimum spreading factor	Support for 10 and 2 ms TTI EDCH	Maximum number of bits of an E-DCH transport block transmitted within a 10 ms E-DCH TTI	Maximum number of bits of an E-DCH transport block transmitted within a 2 ms E-DCH TTI
Category 1	1	SF4	10 ms TTI only	7110	-
Category 2	2	SF4	10 ms and 2 ms TTI	14484	2798
Category 3	2	SF4	10 ms TTI only	14484	-
Category 4	2	SF2	10 ms and 2 ms TTI	20000	5772
Category 5	2	SF2	10 ms TTI only	20000	-
Category 6	4	SF2	10 ms and 2 ms TTI	20000	11484
Category 7	4	SF2	10ms and 2 ms TTI	20000	22996
Category 8	4	SF2	2 ms TTI	-	11484
Category 9	4	SF2	2 ms TTI	-	22996

NOTE: When 4 codes are transmitted in parallel, two codes shall be transmitted with SF2 and two with SF4

2.5. Position of Module in Portable Devices

The measurements were performed in combination with two host products (IBM T61 and Lenovo Y-450). IBM T61 laptop has horizontal USB slot, Lenovo Y-450 laptop has vertical USB slot.

A test distance of 5mm or less, according to KDB 447498 D02, should be considered for the orientation that can satisfy such requirements.

For each channel, the EUT is tested at the following 4 test positions:

- Test Position 1: The EUT is connected to the portable computer with horizontal USB slot. The back side of the EUT towards to the bottom of the flat phantom. The distance from back side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX H Picture 6)
- Test Position 2: The EUT is connected to the portable computer through a 19 cm USB cable. The front side of the EUT towards the bottom of the flat phantom. The distance from front side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX H Picture 7)
- Test Position 3: The EUT is connected to the portable computer through a 19 cm USB cable. The left side of the EUT towards the bottom of the flat phantom. The distance from left side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX H Picture 8)
- Test Position 4: The EUT is connected to the portable computer with vertical USB slot. The right side of the EUT towards the bottom of the flat phantom. The distance from right side of the EUT to the bottom of the flat phantom is 5mm. (ANNEX H Picture 9)

2.6. Picture of Host Product

During the test, IBM T61 and Lenovo Y-450 laptop were used as an assistant to help to setup communication. (See Picture 1)



Picture 1-a: IBM T61 Close



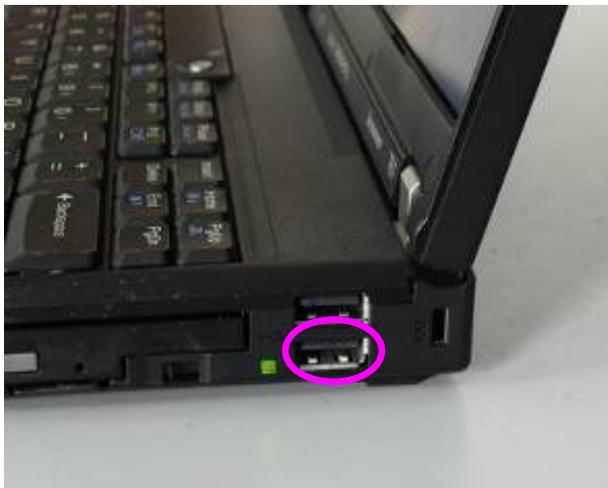
Picture 1-b: IBM T61 Open



Picture 1-c: Lenovo Y-450 Close



Picture 1-d: Lenovo Y-450 Open



Picture 1-e: IBM T61 with horizontal USB slot



Picture 1-f: Lenovo Y-450 with Vertical USB slot



Picture 1-g: a 19 cm USB cable

Picture 1: Computer as a test assistant

3. SAR Measurements System Configuration

3.1. SAR Measurement Set-up

The DASY4 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Stäubli RX family) with controller and software. An arm extension for accommodating the data acquisition electronics (DAE).
- A dosimetric probe, i.e. an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
- A data acquisition electronic (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- A unit to operate the optical surface detector which is connected to the EOC.
- The Electro-Optical Coupler (EOC) performs the conversion from the optical into a digital electric signal of the DAE. The EOC is connected to the DASY4 measurement server.
- The DASY4 measurement server, which performs all real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operation. A computer operating Windows 2003
- DASY4 software and SEMCAD data evaluation software.
- Remote control with teach panel and additional circuitry for robot safety such as warning lamps, etc.
- The generic twin phantom enabling the testing of left-hand and right-hand usage.
- The device holder for handheld mobile phones.
- Tissue simulating liquid mixed according to the given recipes.
- System validation dipoles allowing to validate the proper functioning of the system.

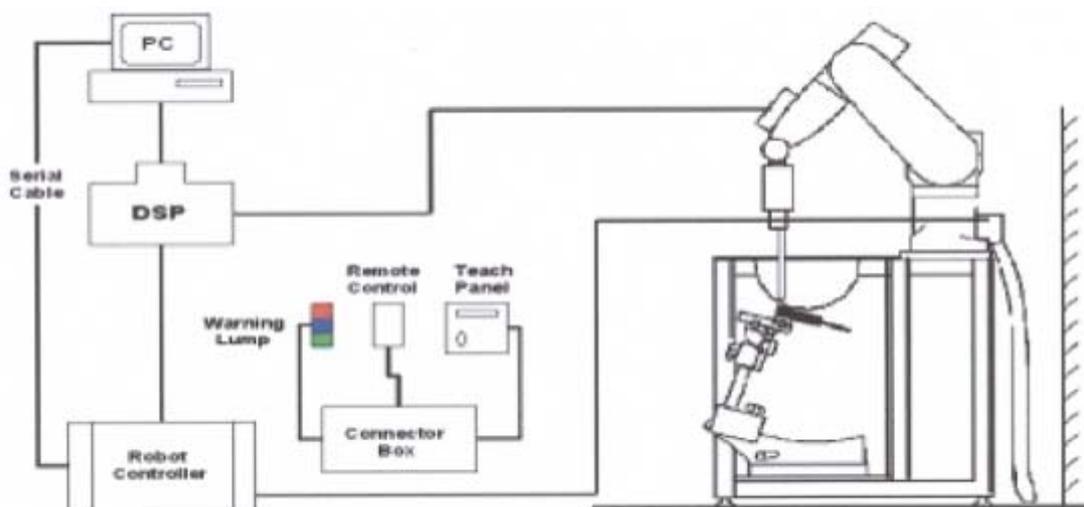


Figure 1. SAR Lab Test Measurement Set-up

3.2. DASY4 E-field Probe System

The SAR measurements were conducted with the dosimetric probe EX3DV4 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

3.2.1. EX3DV4 Probe Specification

Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)
Calibration	ISO/IEC 17025 calibration service available
Frequency	10 MHz to > 6 GHz Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis)
Dynamic Range	10 μ W/g to > 100 mW/g Linearity: ± 0.2 dB (noise: typically < 1 μ W/g)
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm
Application	High precision dosimetric measurements in any exposure scenario (e.g., very strong gradient fields). Only probe which enables compliance testing for frequencies up to 6 GHz with precision of better 30%.



Figure 2. EX3DV4 E-field Probe



Figure 3. EX3DV4 E-field probe

3.2.2. E-field Probe Calibration

Each probe is calibrated according to a dosimetric assessment procedure with accuracy better than $\pm 10\%$. The spherical isotropy was evaluated and found to be better than $\pm 0.25\text{dB}$. The sensitivity parameters (NormX, NormY, NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested.

The free space E-field from amplified probe outputs is determined in a test chamber. This is performed in a TEM cell for frequencies below 1 GHz, and in a wave guide above 1 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. The probe is then rotated 360 degrees.

E-field temperature correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue. The measured free space E-field in the medium correlates to temperature rise in a dielectric medium. For temperature correlation calibration a RF transparent thermistor-based temperature probe is used in conjunction with the E-field probe.

$$\text{SAR} = C \frac{\Delta T}{\Delta t}$$

Where: Δt = Exposure time (30 seconds),
C = Heat capacity of tissue (brain or muscle),
 ΔT = Temperature increase due to RF exposure.
Or

$$\text{SAR} = \frac{|E|^2 \sigma}{\rho}$$

Where:
 σ = Simulated tissue conductivity,
 ρ = Tissue density (kg/m³).

3.3. Other Test Equipment

3.3.1. Device Holder for Transmitters

Construction: Simple but effective and easy-to-use extension for Mounting Device that facilitates the testing of larger devices according to IEC 62209-2 (e.g., laptops, cameras, etc.) It is lightweight and fits easily on the upper part of the Mounting Device in place of the phone positioner. The extension is fully compatible with the Twin SAM, ELI4 and SAM v6.0 Phantoms.

Material: POM, Acrylic glass, Foam

3.3.2. Phantom

The Generic Twin Phantom is constructed of a fiberglass shell integrated in a wooden Figure. The shape of the shell is based on data from an anatomical study designed to determine the maximum exposure in at least 90% of all users. It enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region. A cover prevents the evaporation of the liquid. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.

Shell Thickness	2±0.1 mm
Filling Volume	Approx. 20 liters
Dimensions	810 x 1000 x 500 mm (H x L x W)
Available	Special



Figure 4. Generic Twin Phantom

3.4. Scanning Procedure

The DASY4 installation includes predefined files with recommended procedures for measurements and validation. They are read-only document files and destined as fully defined but unmeasured masks. All test positions (head or body-worn) are tested with the same configuration of test steps differing only in the grid definition for the different test positions.

- The “reference” and “drift” measurements are located at the beginning and end of the batch process. They measure the field drift at one single point in the liquid over the complete procedure. The indicated drift is mainly the variation of the DUT’s output power and should vary max. ± 5 %.
- The “surface check” measurement tests the optical surface detection system of the DASY4 system by repeatedly detecting the surface with the optical and mechanical surface detector and comparing the results. The output gives the detecting heights of both systems, the difference between the two systems and the standard deviation of the detection repeatability. Air bubbles or refraction in the liquid due to separation of the sugar-water mixture gives poor repeatability (above ± 0.1mm). To prevent wrong results tests are only executed when the liquid is free of air bubbles. The difference between the optical surface detection and the actual surface depends on the probe and is specified with each probe. (It does not depend on the surface reflectivity or the probe angle to the surface within ± 30°.)
- Area Scan

The Area Scan is used as a fast scan in two dimensions to find the area of high field values before running a detailed measurement around the hot spot. Before starting the area scan a grid spacing of 10 mm x 10 mm is set. During the scan the distance of the probe to the phantom remains

unchanged.

After finishing area scan, the field maxima within a range of 2 dB will be ascertained.

- **Zoom Scan**

Zoom Scans are used to estimate the peak spatial SAR values within a cubic averaging volume containing 1 g and 10 g of simulated tissue. The default Zoom Scan is done by 7x7x7 points within a cube whose base is centered around the maxima found in the preceding area scan.

- **Spatial Peak Detection**

The procedure for spatial peak SAR evaluation has been implemented and can determine values of masses of 1g and 10g, as well as for user-specific masses. The DASY4 system allows evaluations that combine measured data and robot positions, such as:

- maximum search
- extrapolation
- boundary correction
- peak search for averaged SAR

During a maximum search, global and local maxima searches are automatically performed in 2-D after each Area Scan measurement with at least 6 measurement points. It is based on the evaluation of the local SAR gradient calculated by the Quadratic Shepard's method. The algorithm will find the global maximum and all local maxima within -2 dB of the global maxima for all SAR distributions.

Extrapolation routines are used to obtain SAR values between the lowest measurement points and the inner phantom surface. The extrapolation distance is determined by the surface detection distance and the probe sensor offset. Several measurements at different distances are necessary for the extrapolation. Extrapolation routines require at least 10 measurement points in 3-D space.

They are used in the Zoom Scan to obtain SAR values between the lowest measurement points and the inner phantom surface. The routine uses the modified Quadratic Shepard's method for extrapolation. For a grid using 7x7x7 measurement points with 5mm resolution amounting to 343 measurement points, the uncertainty of the extrapolation routines is less than 1% for 1g and 10g cubes.

- A Z-axis scan measures the total SAR value at the x-and y-position of the maximum SAR value found during the cube 7x7x7 scan. The probe is moved away in z-direction from the bottom of the SAM phantom in 5mm steps.

3.5. Data Storage and Evaluation

3.5.1. Data Storage

The DASY4 software stores the acquired data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files with the extension “.DA4”. The software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of incorrect parameter settings. For example, if a measurement has been performed with a wrong crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be re-evaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type ([V/m], [A/m], [°C], [mW/g], [mW/cm²], [dBrel], etc.). Some of these units are not available in certain situations or show meaningless results, e.g., a SAR output in a lossless media will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

3.5.2. Data Evaluation by SEMCAD

The SEMCAD software automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Normi, a _{i0} , a _{i1} , a _{i2}
	- Conversion factor	ConvF _i
	- Diode compression point	Dcp _i
Device parameters:	- Frequency	f
	- Crest factor	cf
Media parameters:	- Conductivity	
	- Density	

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY4 components. In the direct measuring mode of the multimeter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics.

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If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot c f / d c p_i$$

With V_i = compensated signal of channel i (i = x, y, z)

U_i = input signal of channel i (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes: $E_i = (V_i / Norm_i \cdot ConvF)^{1/2}$

H-field probes: $H_i = (V_i)^{1/2} \cdot (a_{i0} + a_{i1} f + a_{i2} f^2) / f$

With V_i = compensated signal of channel i (i = x, y, z)

$Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
[mV/(V/m)²] for E-field Probes

$ConvF$ = sensitivity enhancement in solution

a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i = electric field strength of channel i in V/m

H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = (E_x^2 + E_y^2 + E_z^2)^{1/2}$$

The primary field data are used to calculate the derived field units.

$$SAR = (E_{tot}^2 \cdot \rho) / (\cdot 1000)$$

with SAR = local specific absorption rate in mW/g

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E_{tot} = total field strength in V/m

σ = conductivity in [mho/m] or [Siemens/m]

ρ = equivalent tissue density in g/cm³

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid. The power flow density is calculated assuming the excitation field to be a free space field.

$$P_{pwe} = E_{tot}^2 / 3770 \quad \text{or} \quad P_{pwe} = H_{tot}^2 \cdot 37.7$$

with P_{pwe} = equivalent power density of a plane wave in mW/cm²

E_{tot} = total electric field strength in V/m

H_{tot} = total magnetic field strength in A/m

3.6. System Check

The manufacturer calibrates the probes annually. Dielectric parameters of the tissue simulants were measured every day using the dielectric probe kit and the network analyzer. A system check measurement was made following the determination of the dielectric parameters of the simulant, using the dipole validation kit. A power level of 250 mW was supplied to the dipole antenna, which was placed under the flat section of the twin SAM phantom. The system check results (dielectric parameters and SAR values) are given in the table 11.

System check results have to be equal or near the values determined during dipole calibration with the relevant liquids and test system ($\pm 10\%$).

System check is performed regularly on all frequency bands where tests are performed with the DASY4 system.

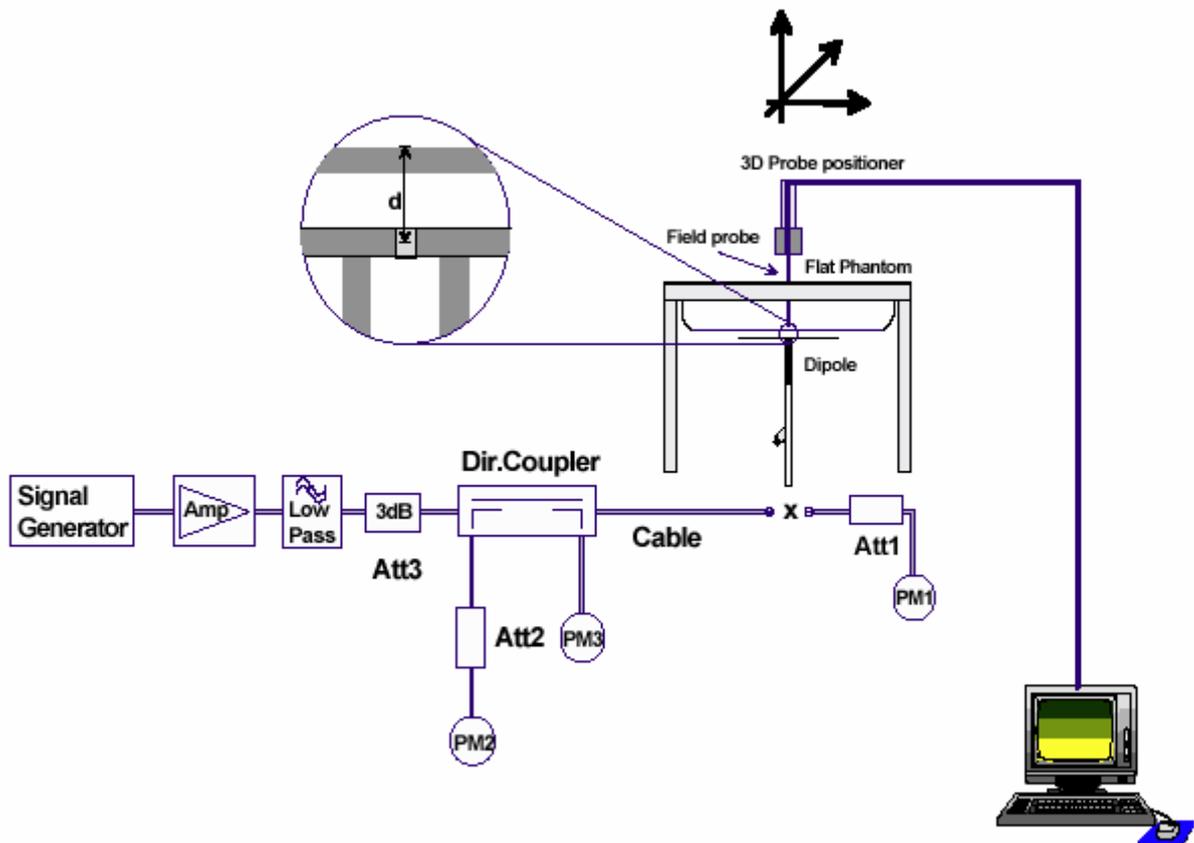


Figure 5. System Check Set-up

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3.7. Equivalent Tissues

The liquid is consisted of water, sugar, salt, Glycol monobutyl, Preventol and Cellulose. The liquid has previously been proven to be suited for worst-case. The Table 7 shows the detail solution. It's satisfying the latest tissue dielectric parameters requirements proposed by OET 65.

Table 7: Composition of the Body Tissue Equivalent Matter

MIXTURE%	FREQUENCY(Body) 835MHz		
Water	52.5		
Sugar	45		
Salt	1.4		
Preventol	0.1		
Cellulose	1.0		
Dielectric Parameters Target Value	f=835MHz	$\epsilon=55.2$	$\sigma=0.97$

MIXTURE%	FREQUENCY (Body) 1900MHz		
Water	69.91		
Glycol monobutyl	29.96		
Salt	0.13		
Dielectric Parameters Target Value	f=1900MHz	$\epsilon=53.3$	$\sigma=1.52$

4. Laboratory Environment

Table 8: The Ambient Conditions during Test

Temperature	Min. = 20°C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards.	
Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

5. Characteristics of the Test

5.1. Applicable Limit Regulations

IEEE Std C95.1, 1999: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

5.2. Applicable Measurement Standards

SUPPLEMENT C Edition 01-01 to OET BULLETIN 65 Edition 97-01 June 2001 including DA 02-1438, published June 2002: Evaluating Compliance with FCC Guidelines for Human Exposure to Radio frequency Electromagnetic Fields Additional Information for Evaluation Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radio frequency Emissions.

KDB 447498 D02 SAR Procedures for Dongle Xmtr v02: SAR Measurement Procedures for USB Dongle Transmitters.

6. Conducted Output Power Measurement

6.1. Summary

The DUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

6.2. Conducted Power Results

Table 9: Conducted Power Measurement Results

WCDMA Band II	Conducted Power (dBm)		
	Channel 9262	Channel 9400	Channel 9538
12.2kbps RMC	22.45	22.52	22.56
64kbps RMC	22.41	22.51	22.54
144kbps RMC	22.43	22.5	22.52
384kbps RMC	22.42	22.51	22.53
WCDMA Band II HSDPA	Conducted Power (dBm)		
	Channel 9262	Channel 9400	Channel 9538
Sub - Test 1	22.43	22.6	22.56
Sub - Test 2	22.51	22.48	22.51
Sub - Test 3	22.01	21.91	22.02
Sub - Test 4	22.88	21.89	22
WCDMA Band II HSUPA	Conducted Power (dBm)		
	Channel 9262	Channel 9400	Channel 9538
Sub - Test 1	21.01	20.70	21.18
Sub - Test 2	20.21	19.90	20.38
Sub - Test 3	20.41	20.20	20.68
Sub - Test 4	20.20	20.00	20.37
Sub - Test 5	21.00	20.68	21.16
WCDMA Band V	Conducted Power (dBm)		
	Channel 4132	Channel 4183	Channel 4233
12.2kbps RMC	22.1	22.16	21.98
64kbps RMC	22.08	22.15	21.96
144kbps RMC	22.7	22.14	21.95
384kbps RMC	22.05	22.12	21.94

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WCDMA Band V HSDPA	Conducted Power (dBm)		
	Channel 4132	Channel 4183	Channel 4233
Sub - Test 1	22.05	22.15	21.89
Sub - Test 2	22.05	22.13	21.88
Sub - Test 3	21.54	21.65	21.36
Sub - Test 4	21.52	21.63	21.34
WCDMA Band V HSUPA	Conducted Power (dBm)		
	Channel 4132	Channel 4183	Channel 4233
Sub - Test 1	20.05	20.3	20.22
Sub - Test 2	19.25	19.5	19.42
Sub - Test 3	19.55	19.8	19.72
Sub - Test 4	19.24	19.52	19.43
Sub - Test 5	20.03	20.28	20.21

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7. Test Results

7.1. Dielectric Performance

Table 10: Dielectric Performance of Body Tissue Simulating Liquid

Frequency	Description	Dielectric Parameters		Temp °C
		ϵ_r	σ (s/m)	
835MHz (body)	Target value ±5% window	55.20 52.44 — 57.96	0.97 0.92 — 1.02	/
	Measurement value 2011-10-13	55.89	1.01	21.5
1900MHz (body)	Target value ±5% window	53.30 50.64 — 55.97	1.52 1.44 — 1.60	/
	Measurement value 2011-10-13	51.98	1.56	21.7

7.2. System Check

Table 11: System Check for Body Tissue Simulating Liquid

Frequency	Description	SAR(W/kg)		Dielectric Parameters		Temp °C
		10g	1g	ϵ_r	σ (s/m)	
835MHz	Recommended result ±10% window	1.59 1.43—1.75	2.42 2.18 — 2.66	41.1	0.89	/
	Measurement value 2011-10-13	1.68	2.56	55.89	1.01	21.5
1900 MHz	Recommended result ±10% window	5.55 5.00 — 6.11	10.6 9.54 — 11.66	53.9	1.57	/
	Measurement value 2011-10-13	5.50	10.28	51.98	1.56	21.7

Note: 1. The graph results see ANNEX B.

2. Target Values used derive from the calibration certificate and 250 mW is used as feeding power to the Calibrated dipole.

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7.3. Summary of Measurement Results

7.3.1. WCDMA Band II (WCDMA/HSDPA/HSUPA)

Table 12: SAR Values [WCDMA Band II (WCDMA/HSDPA/HSUPA)]

Limit of SAR		10 g Average	1g Average	Power Drift	Graph Results
		2.0 W/kg	1.6 W/kg	± 0.21 dB	
Test Case Of Body		Measurement Result (W/kg)		Power Drift (dB)	
Different Test Position	Channel	10 g Average	1 g Average		
IBM T61(Distance 5mm)					
Test Position 1	Middle/9400	0.405	0.775	0.083	Figure 8
Test Position 2	High/9538	0.437	0.871	-0.094	Figure 9
	Middle/9400	0.428	0.855	0.035	Figure 10
	Low/9262	0.517	1.05	-0.085	Figure 11
Lenovo Y-450(Distance 5mm)					
Test Position 3	Middle/9400	0.298	0.622	-0.116	Figure 12
Test Position 4	Middle/9400	0.256	0.473	-0.109	Figure 13
Worst Case Position of RMC with HSDPA(Distance 5mm)					
Test Position 2	Low/9262	0.491	0.99	-0.040	Figure 14
Worst Case Position of RMC with HSUPA(Distance 5mm)					
Test Position 2	Low/9262	0.406	0.821	-0.031	Figure 15

Note: 1.The value with blue color is the maximum SAR Value of each test band.

2. The SAR test shall be performed at the high, middle and low frequency channels of each operating mode. If the SAR measured at mid-band channel for each test configuration is at least 3.0 dB (< 0.8W/kg) lower than the SAR limit, testing at the high and low channels is optional.
3. Upper and lower frequencies were measured at the worst case.

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7.3.2. WCDMA Band V (WCDMA/HSDPA/HSUPA)

Table 13: SAR Values [WCDMA Band V (WCDMA/HSDPA/HSUPA)]

Limit of SAR		10 g Average	1g Average	Power Drift	Graph Results
		2.0 W/kg	1.6 W/kg	± 0.21 dB	
Test Case Of Body		Measurement Result (W/kg)		Power Drift (dB)	
Different Test Position	Channel	10 g Average	1 g Average		
IBM T61(Distance 5mm)					
Test Position 1	High/4233	0.330	0.515	-0.048	Figure 16
	Middle/4183	0.307	0.469	-0.067	Figure 17
	Low/4132	0.386	0.590	0.112	Figure 18
Test Position 2	Middle/4183	0.231	0.356	-0.009	Figure 19
Lenovo Y-450(Distance 5mm)					
Test Position 3	Middle/4183	0.109	0.175	-0.069	Figure 20
Test Position 4	Middle/4183	0.222	0.332	-0.041	Figure 21
Worst Case Position of RMC with HSDPA(Distance 5mm)					
Test Position 1	Low/4132	0.377	0.576	-0.054	Figure 22
Worst Case Position of RMC with HSUPA(Distance 5mm)					
Test Position 1	Low/4132	0.302	0.461	-0.071	Figure 23

Note: 1. The value with blue color is the maximum SAR Value of each test band.

2. The SAR test shall be performed at the high, middle and low frequency channels of each operating mode. If the SAR measured at mid-band channel for each test configuration is at least 3.0 dB (< 0.8W/kg) lower than the SAR limit, testing at the high and low channels is optional.

3. Upper and lower frequencies were measured at the worst case.

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8. Measurement Uncertainty

No.	source	Type	Uncertainty Value (%)	Probability Distribution	k	c _i	Standard uncertainty u _i (%)	Degree of freedom V _{eff} or v _i
1	System repetivity	A	0.5	N	1	1	0.5	9
Measurement system								
2	-probe calibration	B	5.9	N	1	1	5.9	∞
3	-axial isotropy of the probe	B	4.7	R	$\sqrt{3}$	$\sqrt{0.5}$	1.9	∞
4	- Hemispherical isotropy of the probe	B	9.4	R	$\sqrt{3}$	$\sqrt{0.5}$	3.9	∞
6	-boundary effect	B	1.9	R	$\sqrt{3}$	1	1.1	∞
7	-probe linearity	B	4.7	R	$\sqrt{3}$	1	2.7	∞
8	- System detection limits	B	1.0	R	$\sqrt{3}$	1	0.6	∞
9	-readout Electronics	B	1.0	N	1	1	1.0	∞
10	-response time	B	0	R	$\sqrt{3}$	1	0	∞
11	-integration time	B	4.32	R	$\sqrt{3}$	1	2.5	∞
12	-noise	B	0	R	$\sqrt{3}$	1	0	∞
13	-RF Ambient Conditions	B	3	R	$\sqrt{3}$	1	1.73	∞
14	-Probe Positioner Mechanical Tolerance	B	0.4	R	$\sqrt{3}$	1	0.2	∞
15	-Probe Positioning with respect to Phantom Shell	B	2.9	R	$\sqrt{3}$	1	1.7	∞
16	-Extrapolation, interpolation and Integration Algorithms for Max. SAR Evaluation	B	3.9	R	$\sqrt{3}$	1	2.3	∞
Test sample Related								
17	-Test Sample Positioning	A	2.9	N	1	1	4.92	71
18	-Device Holder Uncertainty	A	4.1	N	1	1	4.1	5
19	-Output Power Variation - SAR drift measurement	B	5.0	R	$\sqrt{3}$	1	2.9	∞
Physical parameter								
20	-phantom	B	4.0	R	$\sqrt{3}$	1	2.3	∞
21	-liquid conductivity (deviation from target)	B	5.0	R	$\sqrt{3}$	0.64	1.8	∞

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22	-liquid conductivity (measurement uncertainty)	B	0.77	N	1	0.64	0.493	9	
23	-liquid permittivity (deviation from target)	B	5.0	R	$\sqrt{3}$	0.6	1.7	∞	
24	-liquid permittivity (measurement uncertainty)	B	0.29	N	1	0.6	0.174	9	
Combined standard uncertainty		$u_c = \sqrt{\sum_{i=1}^{21} c_i^2 u_i^2}$						11.36	
Expanded uncertainty (confidence interval of 95 %)		$u_e = 2u_c$		N	k=2		22.72		

9. Main Test Instruments

Table 14: List of Main Instruments

No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Network analyzer	Agilent 8753E	US37390326	September 12, 2011	One year
02	Dielectric Probe Kit	Agilent 85070E	US44020115	No Calibration Requested	
03	Power meter	Agilent E4417A	GB41291714	March 12, 2011	One year
04	Power sensor	Agilent N8481H	MY50350004	September 25, 2011	One year
05	Signal Generator	HP 8341B	2730A00804	September 12, 2011	One year
06	Amplifier	IXA-020	0401	No Calibration Requested	
07	BTS	E5515C	MY48360988	December 3, 2010	One year
08	E-field Probe	EX3DV4	3677	November 24, 2010	One year
09	DAE	DAE4	871	November 18, 2010	One year
10	Validation Kit 835MHz	D835V2	4d020	August 26, 2011	One year
11	Validation Kit 1900MHz	D1900V2	5d060	August 31, 2011	One year

END OF REPORT BODY

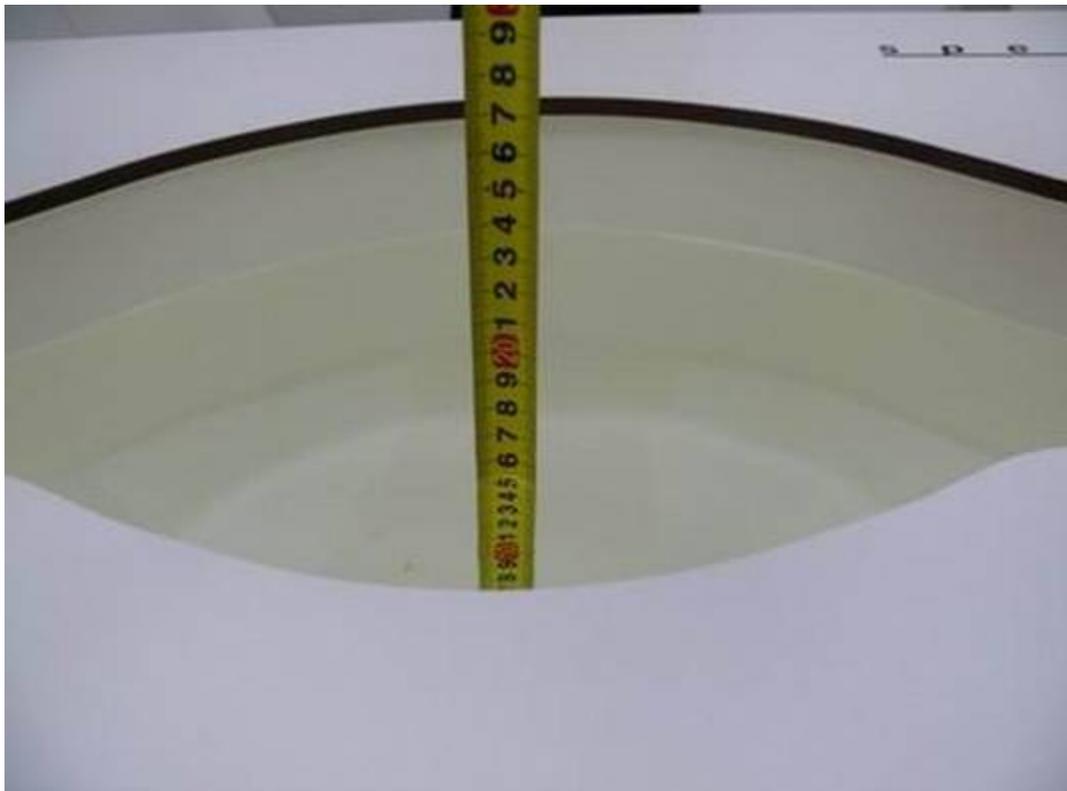
ANNEX A: Test Layout



Picture 2: Specific Absorption Rate Test Layout



Picture 3: Liquid depth in the Flat Phantom (835 MHz, 15.4cm depth)



Picture 4: Liquid depth in the Flat Phantom (1900 MHz, 15.2cm depth)

ANNEX B: System Check Results

System Performance Check at 835 MHz

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Date/Time: 10/13/2011 8:08:20 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 835$ MHz; $\sigma = 1.01$ mho/m; $\epsilon_r = 55.89$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

d=15mm, Pin=250mW/Area Scan (61x121x1): Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 2.77 mW/g

d=15mm, Pin=250mW/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 50.9 V/m; Power Drift = 0.023 dB

Peak SAR (extrapolated) = 3.68 W/kg

SAR(1 g) = 2.56 mW/g; SAR(10 g) = 1.68 mW/g

Maximum value of SAR (measured) = 2.77 mW/g

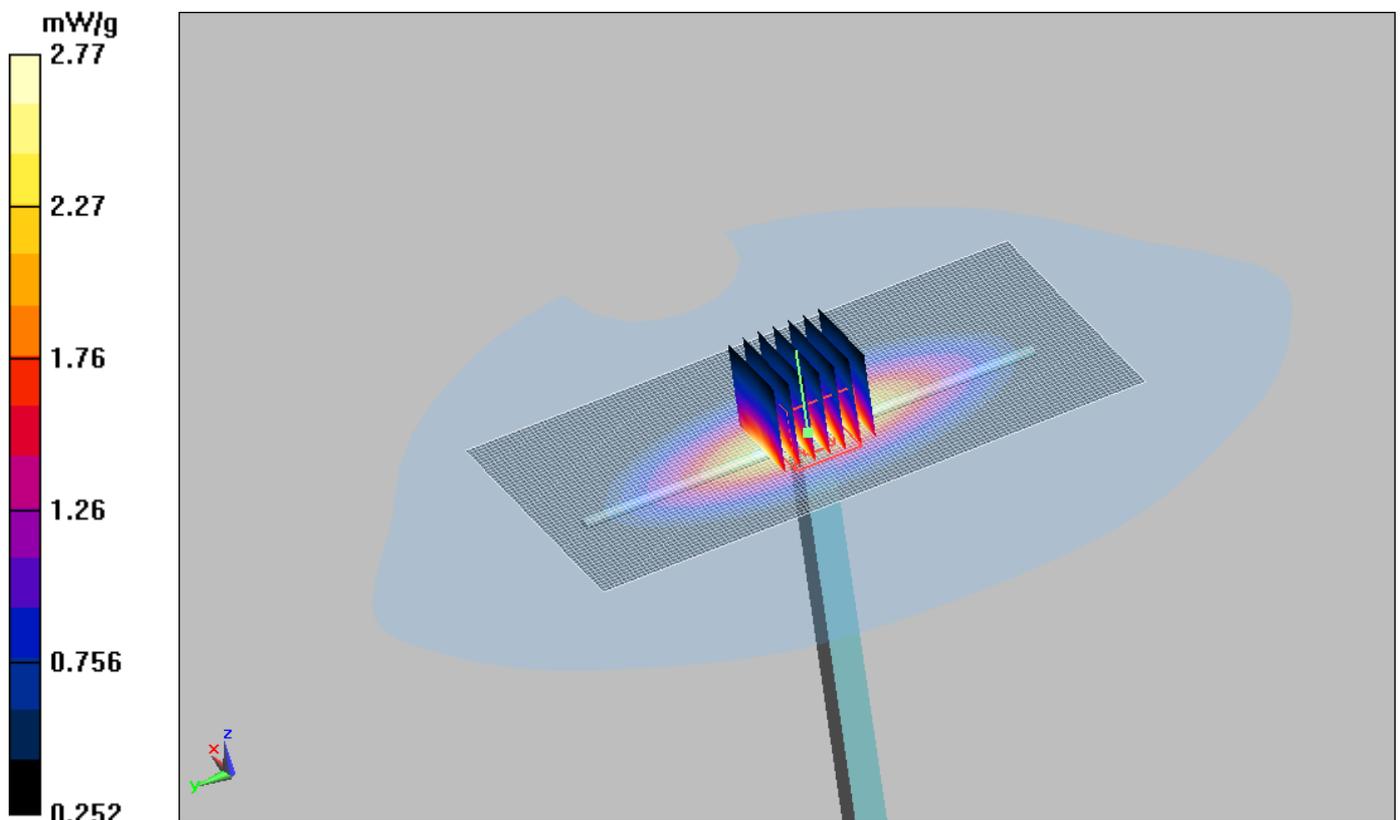


Figure 6 System Performance Check 835MHz 250mW

System Performance Check at 1900 MHz

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN: 5d060

Date/Time: 10/13/2011 1:16:19 PM

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.56$ mho/m; $\epsilon_r = 51.98$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.7 °C

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

d=10mm, Pin=250mW/Area Scan (41x71x1): Measurement grid: dx=150mm, dy=15mm

Maximum value of SAR (interpolated) = 12.5 mW/g

d=10mm, Pin=250mW/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 75.9 V/m; Power Drift = 0.051 dB

Peak SAR (extrapolated) = 16.8 W/kg

SAR(1 g) = 10.28 mW/g; SAR(10 g) = 5.50 mW/g

Maximum value of SAR (measured) = 11 mW/g

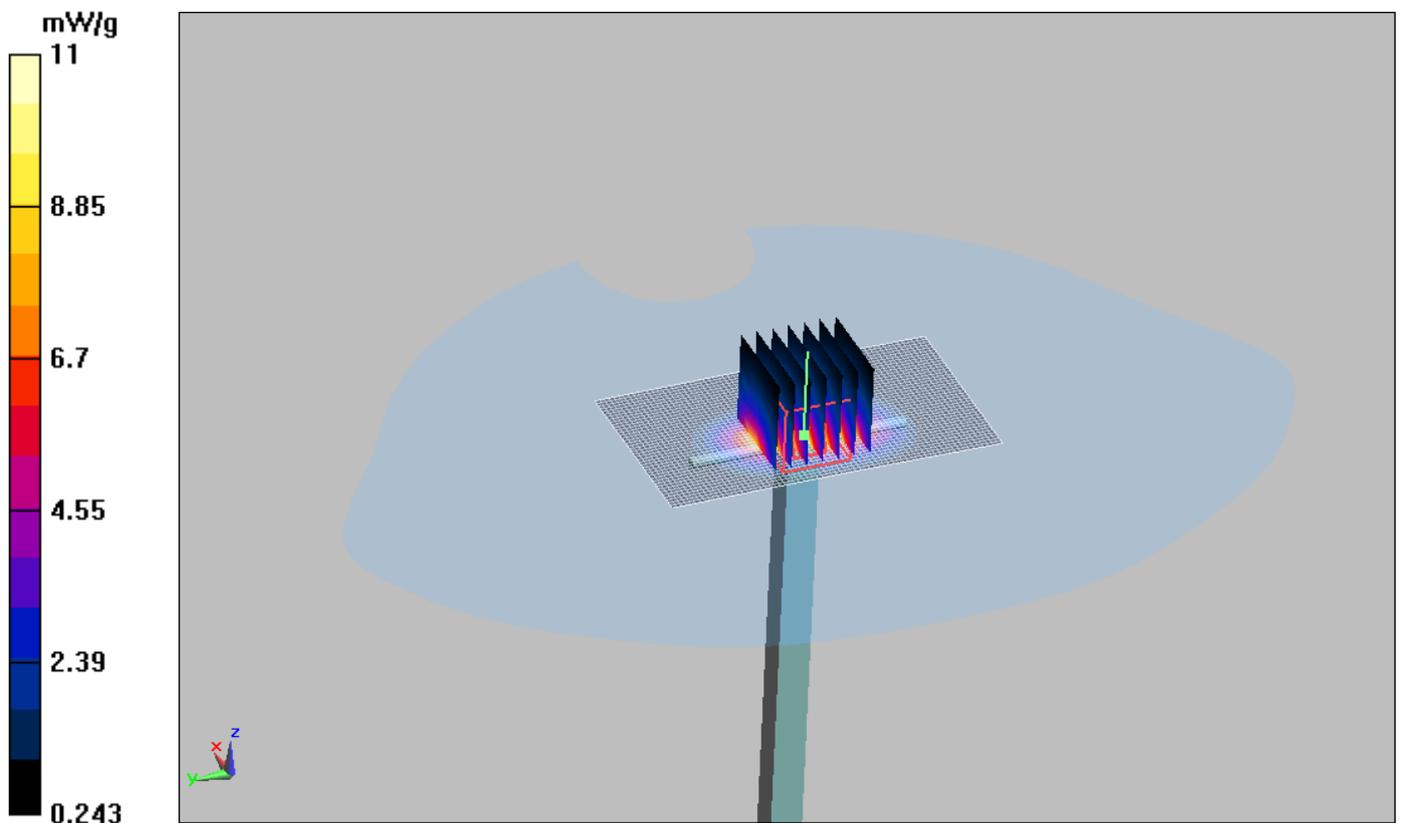


Figure 7 System Performance Check 1900MHz 250mW

ANNEX C: Graph Results

WCDMA Band II with IBM T61 Test Position 1 Middle

Date/Time: 10/13/2011 9:29:58 AM

Communication System: WCDMA Band II; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 1880$ MHz; $\sigma = 1.54$ mho/m; $\epsilon_r = 52$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 1 Middle/Area Scan (41x71x1): Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.909 mW/g

Test Position 1 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 17.2 V/m; Power Drift = 0.083 dB

Peak SAR (extrapolated) = 1.52 W/kg

SAR(1 g) = 0.775 mW/g; SAR(10 g) = 0.405 mW/g

Maximum value of SAR (measured) = 0.846 mW/g

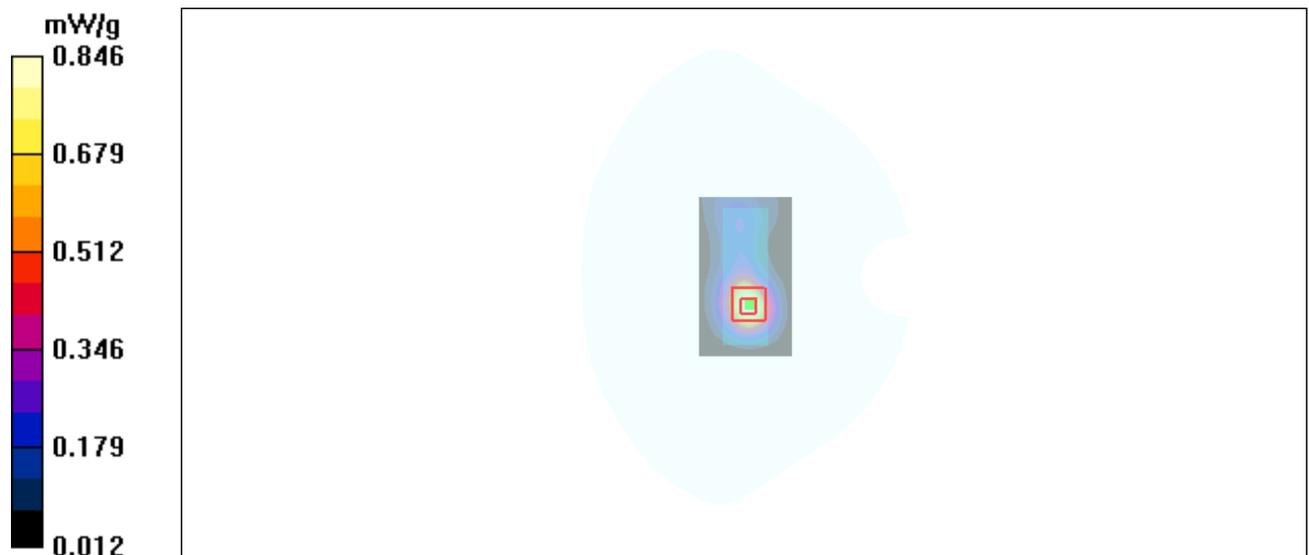


Figure 8 WCDMA Band II with IBM T61 Test Position 1 Channel 9400

WCDMA Band II with IBM T61 Test Position 2 High

Date/Time: 10/13/2011 10:03:39 AM

Communication System: WCDMA Band II; Frequency: 1907.6 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 1908$ MHz; $\sigma = 1.57$ mho/m; $\epsilon_r = 52$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 2 High/Area Scan (61x101x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.986 mW/g

Test Position 2 High/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 16.6 V/m; Power Drift = -0.094 dB

Peak SAR (extrapolated) = 1.83 W/kg

SAR(1 g) = 0.871 mW/g; SAR(10 g) = 0.437 mW/g

Maximum value of SAR (measured) = 0.969 mW/g

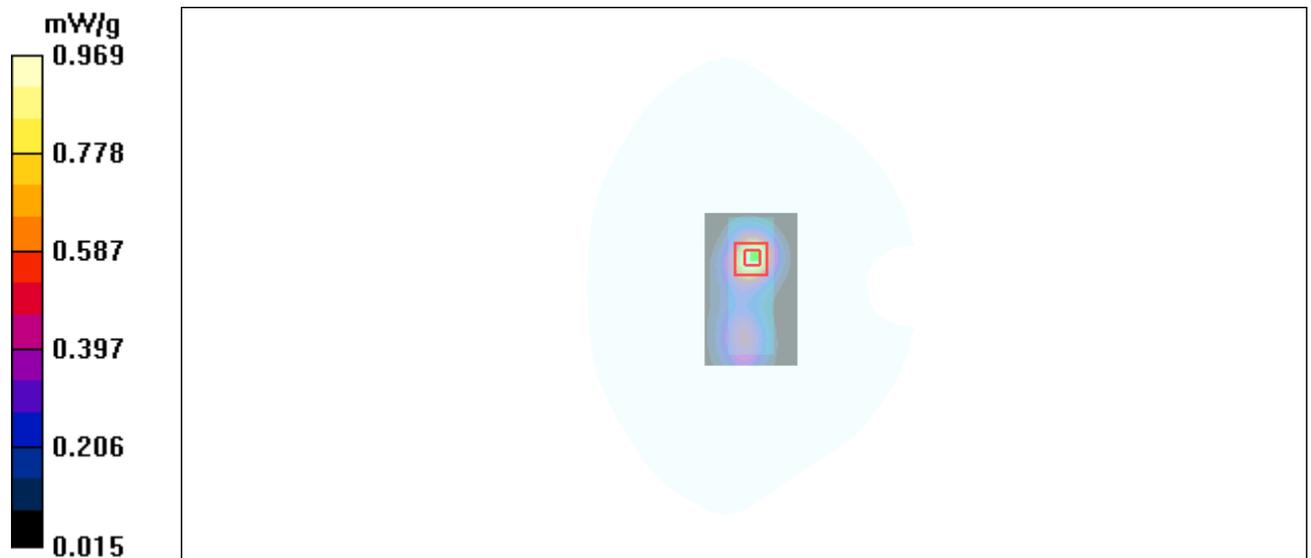


Figure 9 WCDMA Band II with IBM T61 Test Position 2 Channel 9538

WCDMA Band II with IBM T61 Test Position 2 Middle

Date/Time: 10/13/2011 9:46:53 AM

Communication System: WCDMA Band II; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 1880$ MHz; $\sigma = 1.54$ mho/m; $\epsilon_r = 52$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 2 Middle/Area Scan (41x71x1): Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.977 mW/g

Test Position 2 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 16.4 V/m; Power Drift = 0.035 dB

Peak SAR (extrapolated) = 1.79 W/kg

SAR(1 g) = 0.855 mW/g; SAR(10 g) = 0.428 mW/g

Maximum value of SAR (measured) = 0.934 mW/g

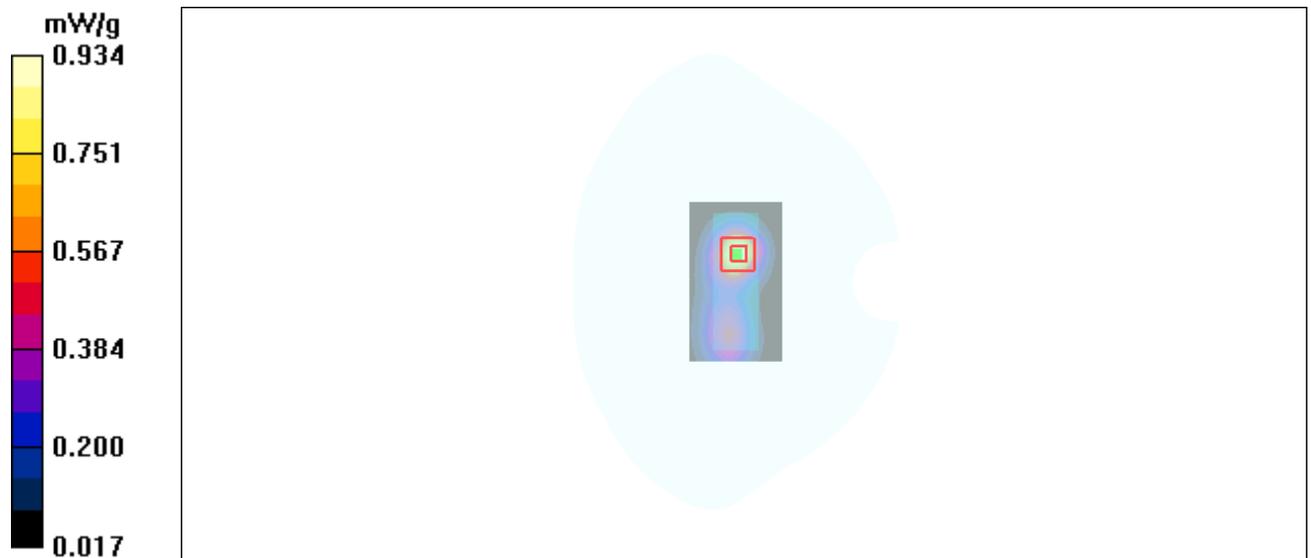


Figure 10 WCDMA Band II with IBM T61 Test Position 2 Channel 9400

WCDMA Band II with IBM T61 Test Position 2 Low

Date/Time: 10/13/2011 10:50:43 PM

Communication System: WCDMA Band II; Frequency: 1852.4 MHz; Duty Cycle: 1:1

Medium parameters used (interpolated): $f = 1852.4$ MHz; $\sigma = 1.51$ mho/m; $\epsilon_r = 52.1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 2 Low/Area Scan (61x101x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 1.23 mW/g

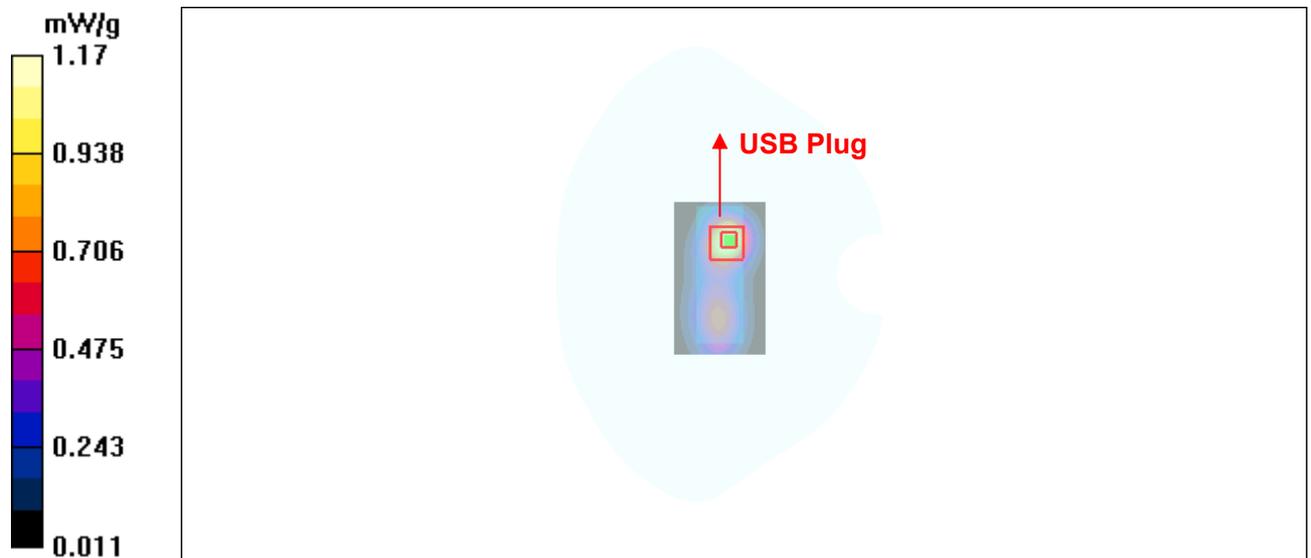
Test Position 2 Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 18.9 V/m; Power Drift = -0.085 dB

Peak SAR (extrapolated) = 2.23 W/kg

SAR(1 g) = 1.05 mW/g; SAR(10 g) = 0.517 mW/g

Maximum value of SAR (measured) = 1.17 mW/g



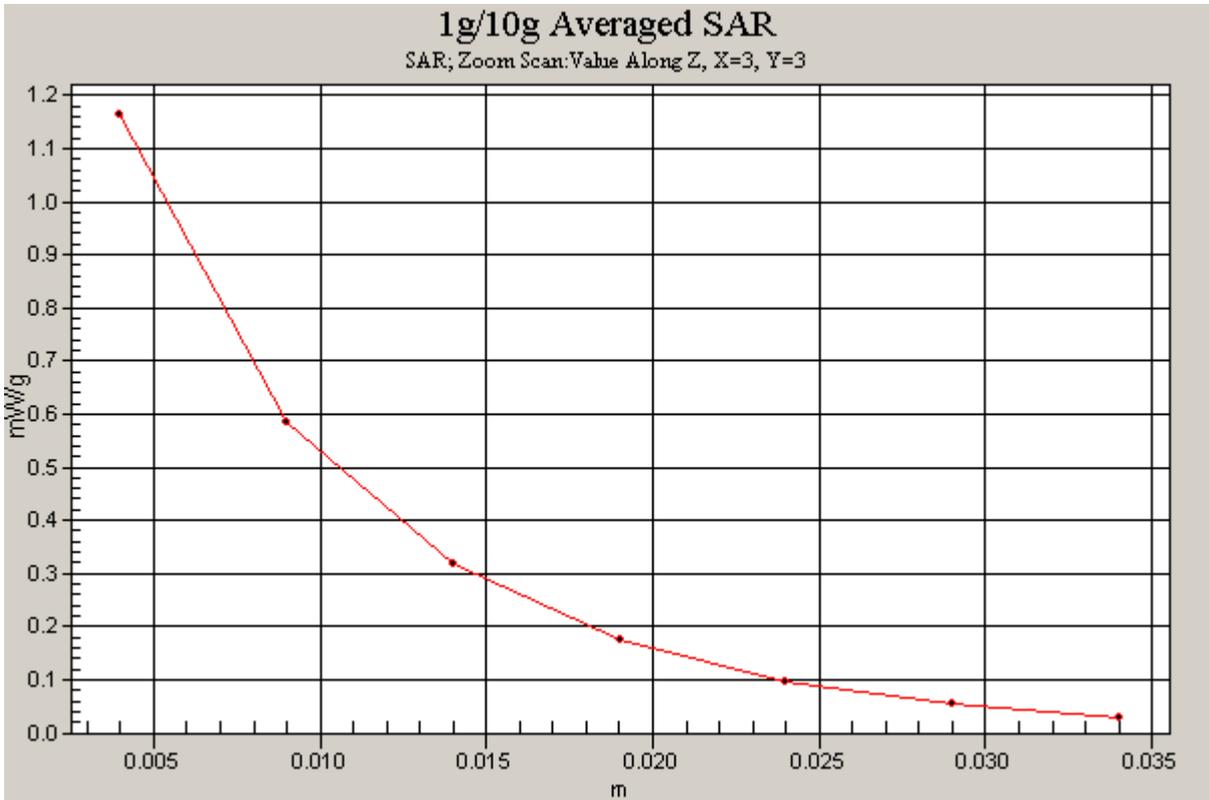


Figure 11 WCDMA Band II with IBM T61 Test Position 2 Channel 9262

WCDMA Band II with Lenovo Y-450 Test Position 3 Middle

Date/Time: 10/13/2011 8:46:25 PM

Communication System: WCDMA Band II; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 1880$ MHz; $\sigma = 1.54$ mho/m; $\epsilon_r = 52$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 3 Middle/Area Scan (31x111x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.726 mW/g

Test Position 3 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 12.9 V/m; Power Drift = -0.116 dB

Peak SAR (extrapolated) = 1.32 W/kg

SAR(1 g) = 0.622 mW/g; SAR(10 g) = 0.298 mW/g

Maximum value of SAR (measured) = 0.698 mW/g

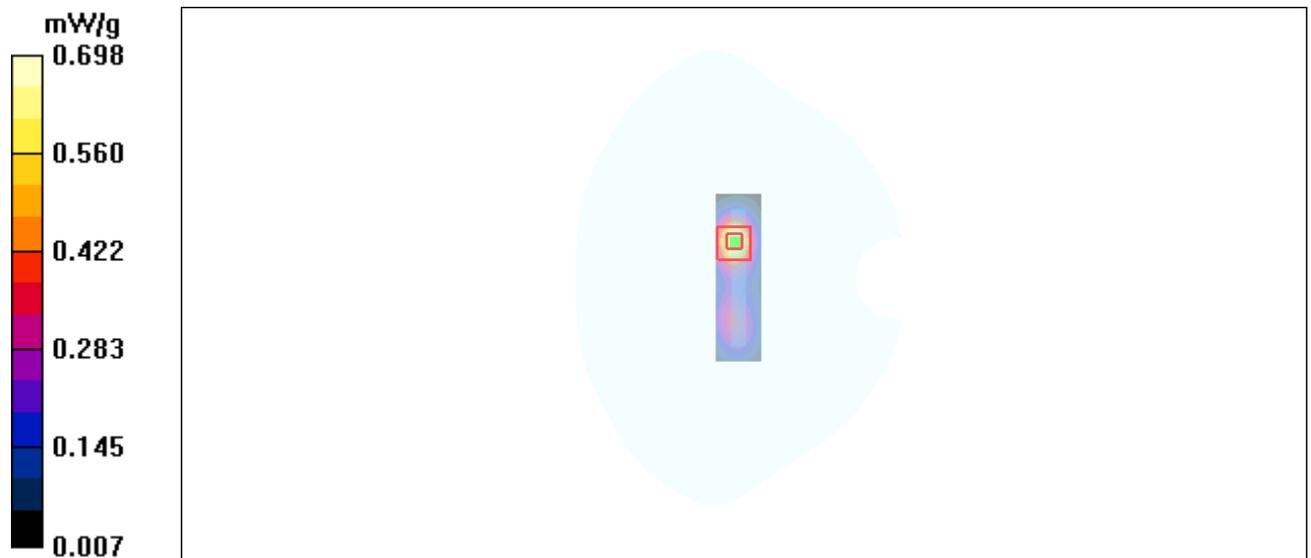


Figure 12 WCDMA Band II with Lenovo Y-450 Test Position 3 Channel 9400

WCDMA Band II with Lenovo Y-450 Test Position 4 Middle

Date/Time: 10/13/2011 8:13:52 PM

Communication System: WCDMA Band II; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 1880$ MHz; $\sigma = 1.54$ mho/m; $\epsilon_r = 52$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 4 Middle/Area Scan (31x111x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.525 mW/g

Test Position 4 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 12.8 V/m; Power Drift = -0.109 dB

Peak SAR (extrapolated) = 0.893 W/kg

SAR(1 g) = 0.473 mW/g; SAR(10 g) = 0.256 mW/g

Maximum value of SAR (measured) = 0.517 mW/g

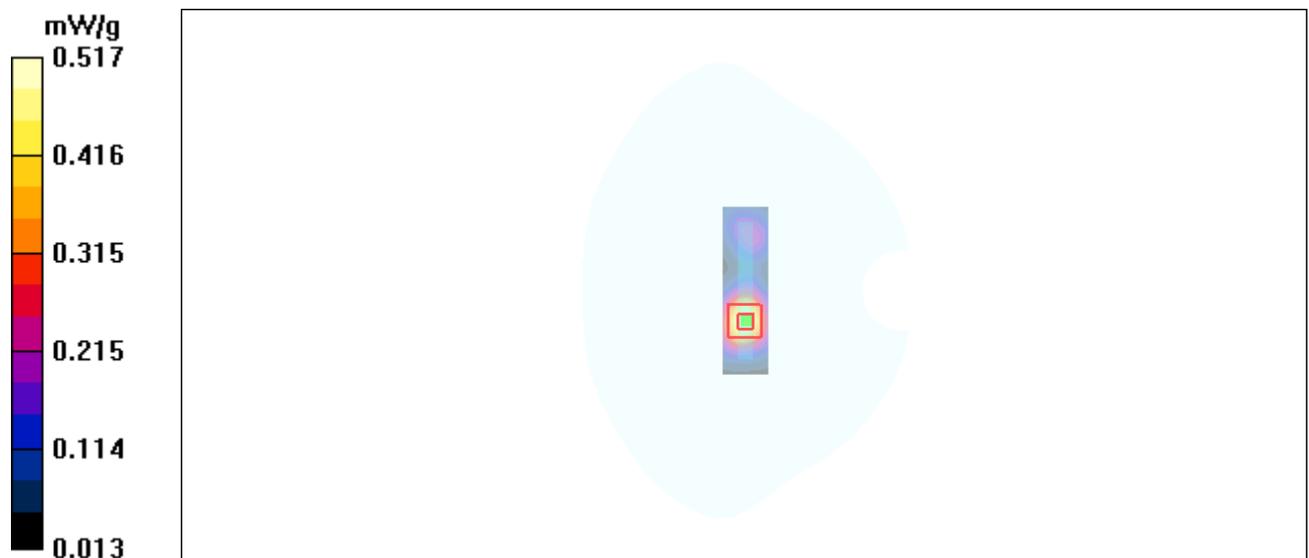


Figure 13 WCDMA Band II with Lenovo Y-450 Test Position 4 Channel 9400

WCDMA Band II HSDPA with IBM T61 Test Position 2 Low

Date/Time: 10/13/2011 9:53:05 PM

Communication System: WCDMA Band II + HSDPA(14); Frequency: 1852.4 MHz; Duty Cycle: 1:1
Medium parameters used (interpolated): $f = 1852.4$ MHz; $\sigma = 1.51$ mho/m; $\epsilon_r = 52.1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 2 Low/Area Scan (41x71x1): Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 1.14 mW/g

Test Position 2 Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 17.9 V/m; Power Drift = -0.040 dB

Peak SAR (extrapolated) = 2.08 W/kg

SAR(1 g) = 0.990 mW/g; SAR(10 g) = 0.491 mW/g

Maximum value of SAR (measured) = 1.09 mW/g

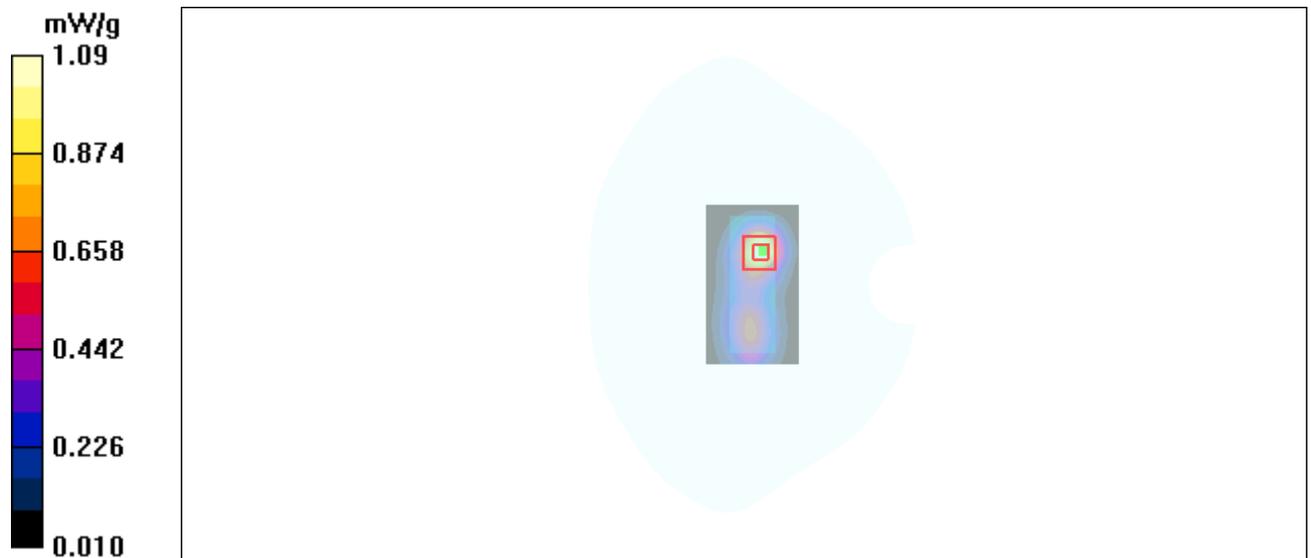


Figure 14 WCDMA Band II HSDPA with IBM T61 Test Position 2 Channel 9262

WCDMA Band II HSUPA with IBM T61 Test Position 2 Low

Date/Time: 10/13/2011 10:22:55 PM

Communication System: WCDMA Band II + HSUPA(6); Frequency: 1852.4 MHz; Duty Cycle: 1:1

Medium parameters used (interpolated): $f = 1852.4$ MHz; $\sigma = 1.51$ mho/m; $\epsilon_r = 52.1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(7.77, 7.77, 7.77); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM000 T01; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 2 Low/Area Scan (41x71x1): Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.976 mW/g

Test Position 2 Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 16.5 V/m; Power Drift = -0.031 dB

Peak SAR (extrapolated) = 1.73 W/kg

SAR(1 g) = 0.821 mW/g; SAR(10 g) = 0.406 mW/g

Maximum value of SAR (measured) = 0.906 mW/g

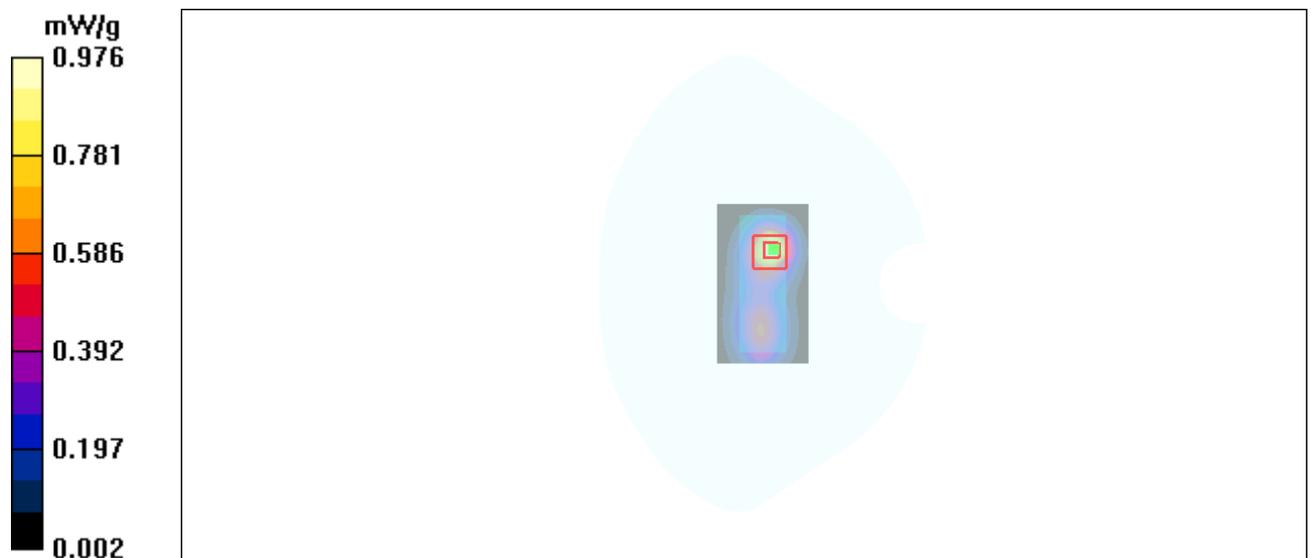


Figure 15 WCDMA Band II HSUPA with IBM T61 Test Position 2 Channel 9262

WCDMA Band V with IBM T61 Test Position 1 High

Date/Time: 10/13/2011 4:43:32 PM

Communication System: WCDMA Band V; Frequency: 846.6 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 847$ MHz; $\sigma = 1.02$ mho/m; $\epsilon_r = 55.8$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 1 High/Area Scan (61x111x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.570 mW/g

Test Position 1 High/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 19.2 V/m; Power Drift = -0.048 dB

Peak SAR (extrapolated) = 0.757 W/kg

SAR(1 g) = 0.515 mW/g; SAR(10 g) = 0.330 mW/g

Maximum value of SAR (measured) = 0.560 mW/g

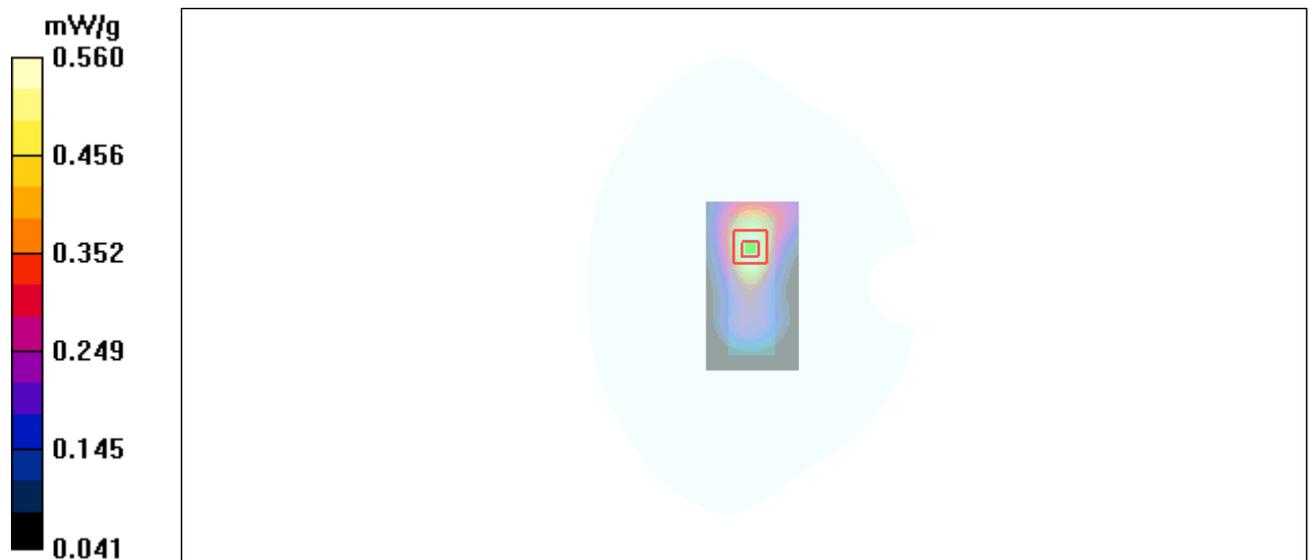


Figure 16 WCDMA Band V with IBM T61 Test Position 1 Channel 4233

WCDMA Band V with IBM T61 Test Position 1 Middle

Date/Time: 10/13/2011 2:36:05 PM

Communication System: WCDMA Band V; Frequency: 836.6 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 837$ MHz; $\sigma = 1.01$ mho/m; $\epsilon_r = 55.9$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 1 Middle/Area Scan (61x101x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.546 mW/g

Test Position 1 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 18.7 V/m; Power Drift = -0.067 dB

Peak SAR (extrapolated) = 0.683 W/kg

SAR(1 g) = 0.469 mW/g; SAR(10 g) = 0.307 mW/g

Maximum value of SAR (measured) = 0.511 mW/g

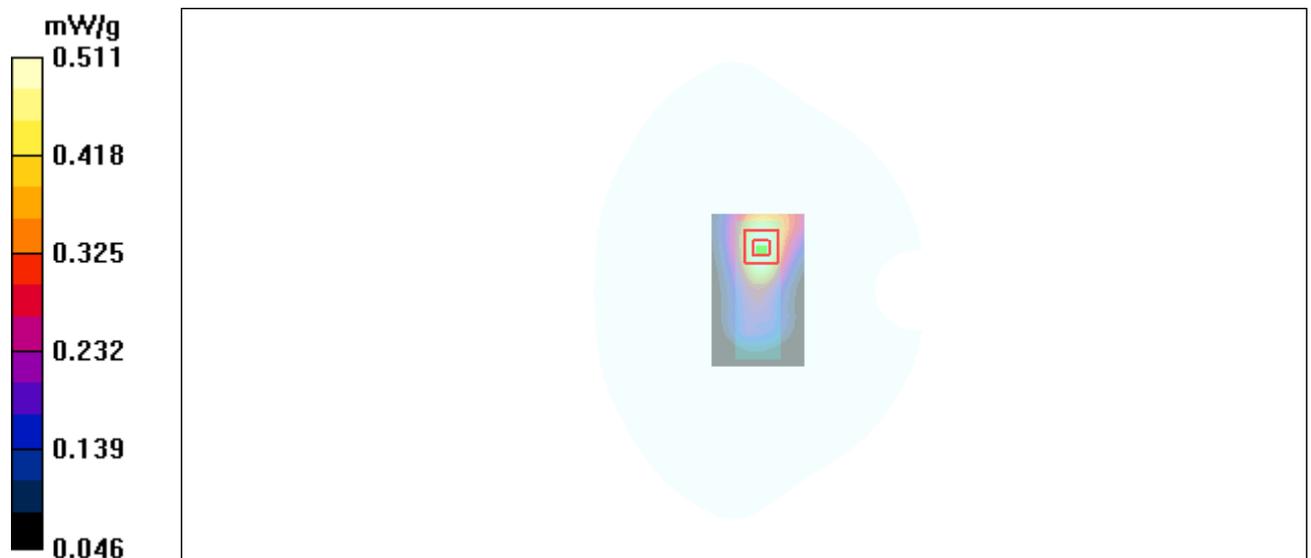


Figure 17 WCDMA Band V with IBM T61 Test Position 1 Channel 4183

WCDMA Band V with IBM T61 Test Position 1 Low

Date/Time: 10/13/2011 5:02:54 PM

Communication System: WCDMA Band V; Frequency: 826.4 MHz; Duty Cycle: 1:1

Medium parameters used (interpolated): $f = 826.4$ MHz; $\sigma = 1$ mho/m; $\epsilon_r = 55.9$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 1 Low/Area Scan (61x111x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.639 mW/g

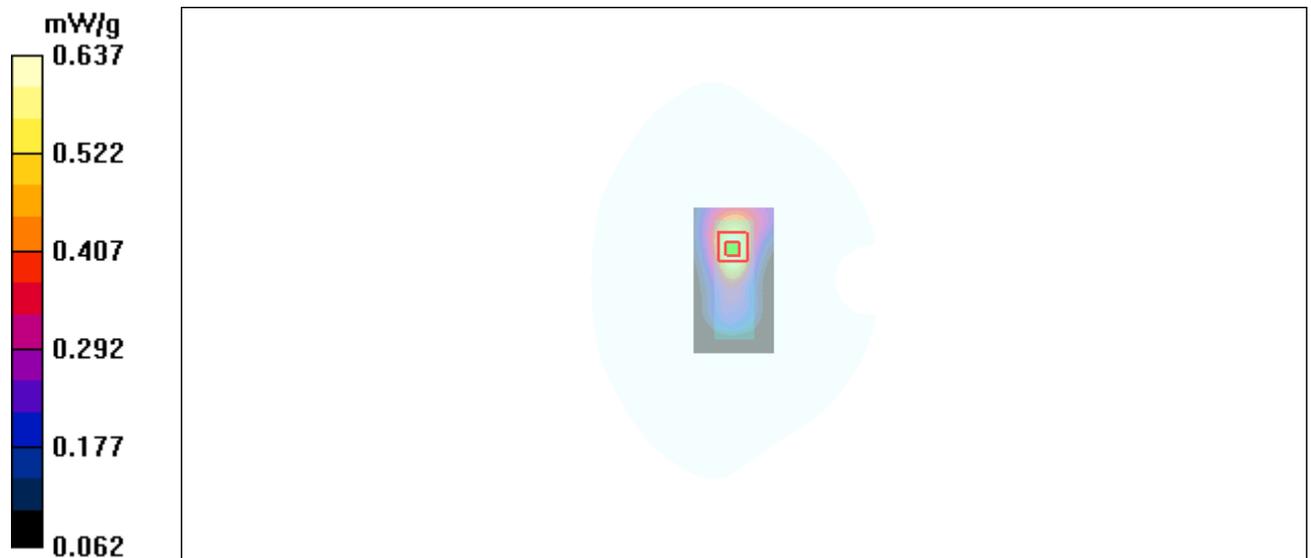
Test Position 1 Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 20.4 V/m; Power Drift = 0.112 dB

Peak SAR (extrapolated) = 0.852 W/kg

SAR(1 g) = 0.590 mW/g; SAR(10 g) = 0.386 mW/g

Maximum value of SAR (measured) = 0.637 mW/g



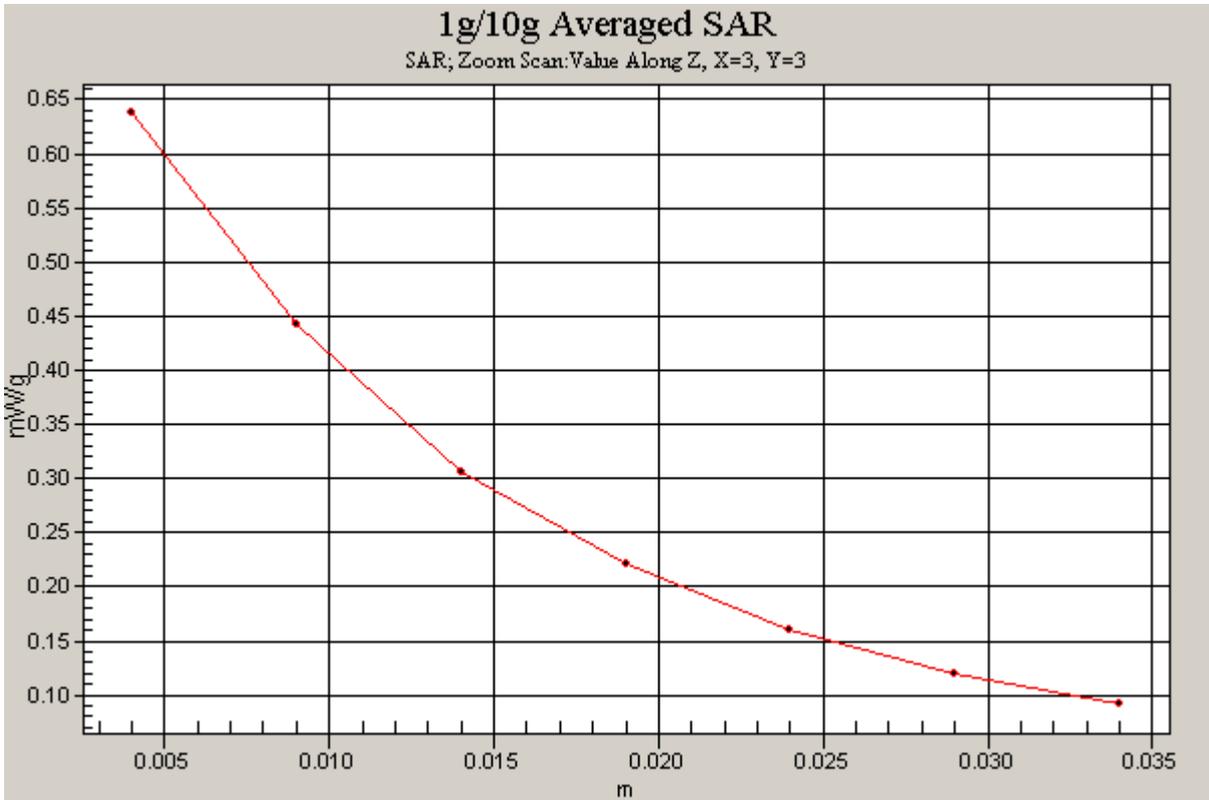


Figure 18 WCDMA Band V with IBM T61 Test Position 1 Channel 4132

WCDMA Band V with IBM T61 Test Position 2 Middle

Date/Time: 10/13/2011 3:09:49 PM

Communication System: WCDMA Band V; Frequency: 836.6 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 837$ MHz; $\sigma = 1.01$ mho/m; $\epsilon_r = 55.9$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 2 Middle/Area Scan (61x101x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.412 mW/g

Test Position 2 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 19.1 V/m; Power Drift = -0.009 dB

Peak SAR (extrapolated) = 0.501 W/kg

SAR(1 g) = 0.356 mW/g; SAR(10 g) = 0.231 mW/g

Maximum value of SAR (measured) = 0.388 mW/g

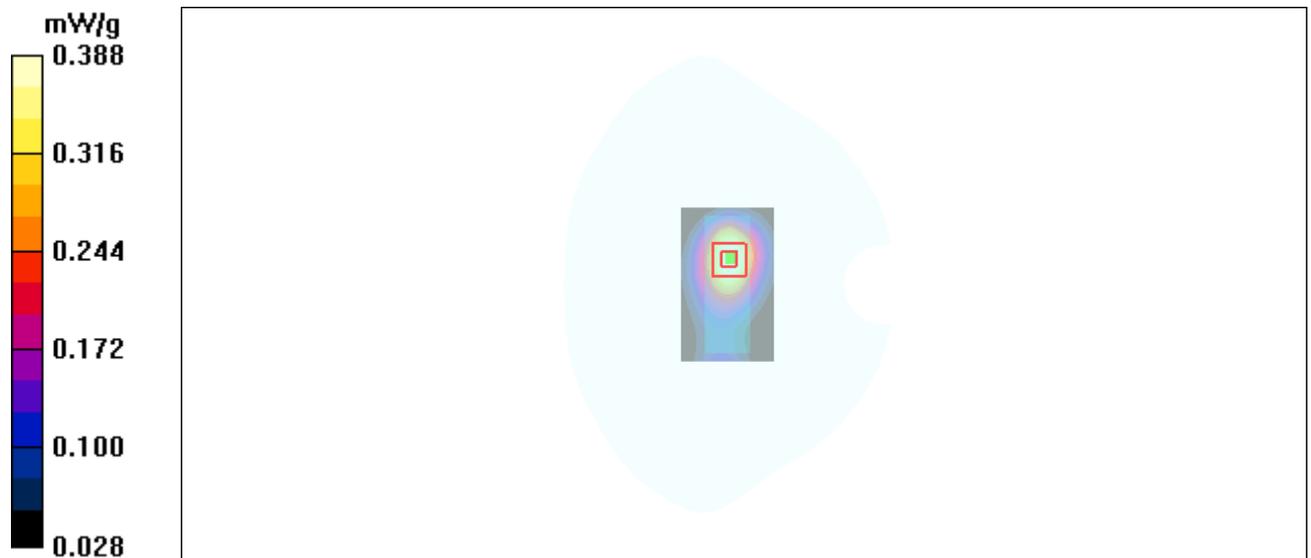


Figure 19 WCDMA Band V with IBM T61 Test Position 2 Channel 4183

WCDMA Band V with Lenovo Y-450 Test Position 3 Middle

Date/Time: 10/13/2011 4:12:49 PM

Communication System: WCDMA Band V; Frequency: 836.6 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 837$ MHz; $\sigma = 1.01$ mho/m; $\epsilon_r = 55.9$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 3 Middle/Area Scan (31x101x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.201 mW/g

Test Position 3 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 13.5 V/m; Power Drift = -0.069 dB

Peak SAR (extrapolated) = 0.270 W/kg

SAR(1 g) = 0.175 mW/g; SAR(10 g) = 0.109 mW/g

Maximum value of SAR (measured) = 0.192 mW/g

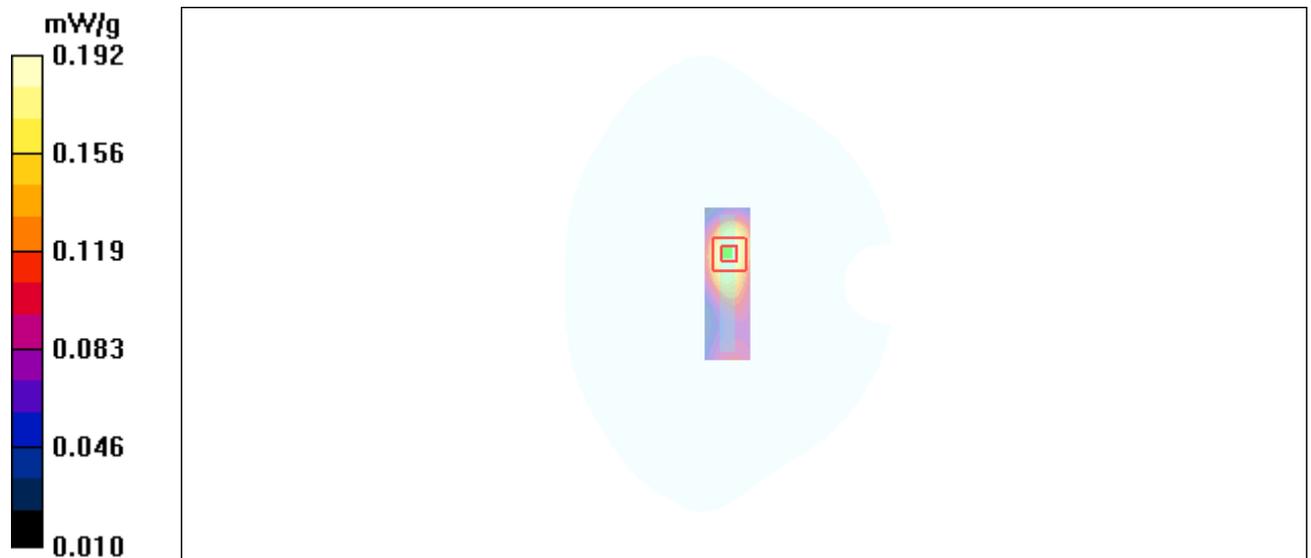


Figure 20 WCDMA Band V with Lenovo Y-450 Test Position 3 Channel 4183

WCDMA Band V with Lenovo Y-450 Test Position 4 Middle

Date/Time: 10/13/2011 3:45:41 PM

Communication System: WCDMA Band V; Frequency: 836.6 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 837$ MHz; $\sigma = 1.01$ mho/m; $\epsilon_r = 55.9$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 4 Middle/Area Scan (31x101x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.385 mW/g

Test Position 4 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 16.2 V/m; Power Drift = -0.041 dB

Peak SAR (extrapolated) = 0.469 W/kg

SAR(1 g) = 0.332 mW/g; SAR(10 g) = 0.222 mW/g

Maximum value of SAR (measured) = 0.360 mW/g



Figure 21 WCDMA Band V with Lenovo Y-450 Test Position 4 Channel 4183

WCDMA Band V HSDPA with IBM T61 Test Position 1 Low

Date/Time: 10/13/2011 5:31:32 PM

Communication System: WCDMA Band V + HSDPA(14); Frequency: 826.4 MHz; Duty Cycle: 1:1

Medium parameters used (interpolated): $f = 826.4$ MHz; $\sigma = 1$ mho/m; $\epsilon_r = 55.9$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 1 Low/Area Scan (61x111x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.647 mW/g

Test Position 1 Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 21.0 V/m; Power Drift = -0.054 dB

Peak SAR (extrapolated) = 0.833 W/kg

SAR(1 g) = 0.576 mW/g; SAR(10 g) = 0.377 mW/g

Maximum value of SAR (measured) = 0.621 mW/g

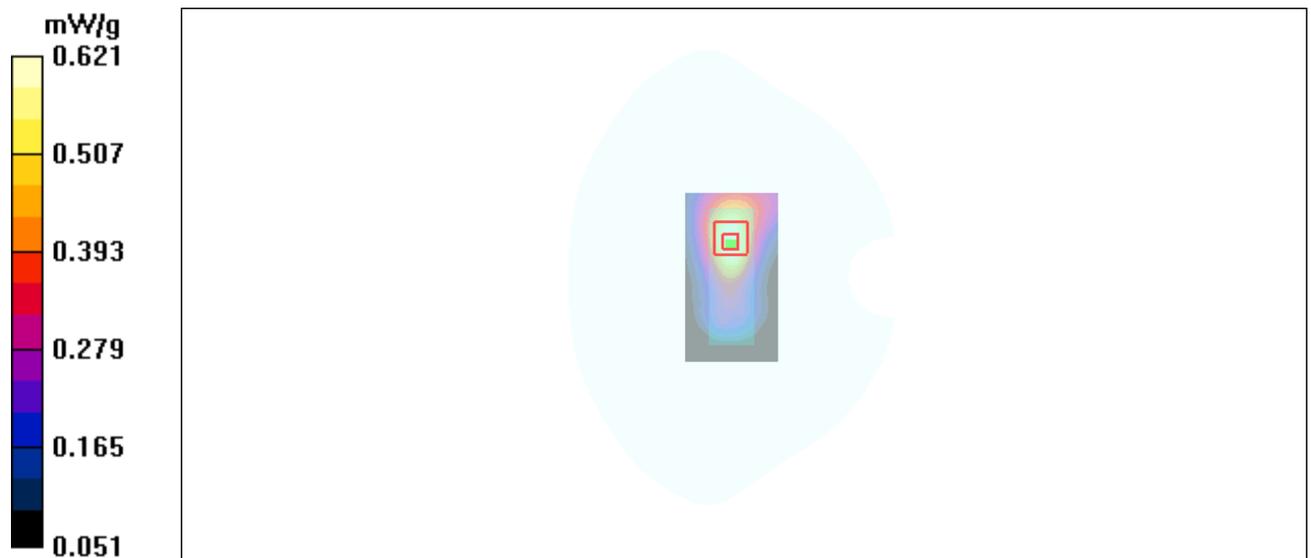


Figure 22 WCDMA Band V HSDPA with IBM T61 Test Position 1 Channel 4132

WCDMA Band V HSUPA with IBM T61 Test Position 1 Low

Date/Time: 10/13/2011 6:44:12 PM

Communication System: WCDMA Band V + HSUPA(6); Frequency: 826.4 MHz; Duty Cycle: 1:1

Medium parameters used (interpolated): $f = 826.4$ MHz; $\sigma = 1$ mho/m; $\epsilon_r = 55.9$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 - SN3677; ConvF(10.33, 10.33, 10.33); Calibrated: 11/24/2010

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 1 Low/Area Scan (61x111x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 0.497 mW/g

Test Position 1 Low/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 18.4 V/m; Power Drift = -0.071 dB

Peak SAR (extrapolated) = 0.672 W/kg

SAR(1 g) = 0.461 mW/g; SAR(10 g) = 0.302 mW/g

Maximum value of SAR (measured) = 0.500 mW/g

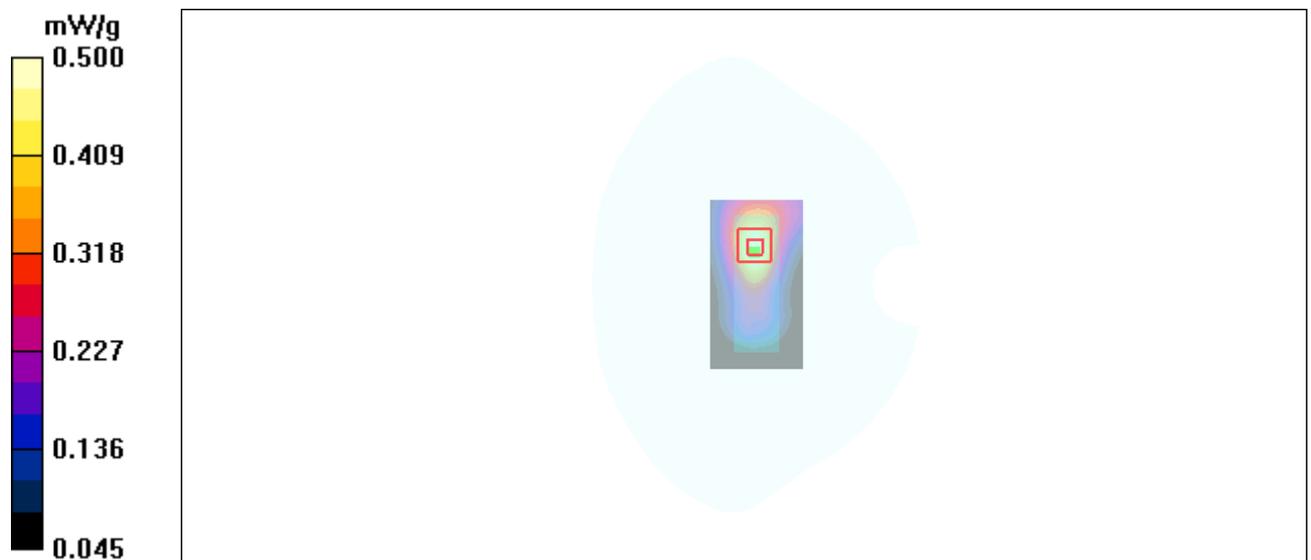


Figure 23 WCDMA Band V HSUPA with IBM T61 Test Position 1 Channel 4132

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA1110-1724SAR01R1

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ANNEX D: Probe Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA-SH (Auden)**

Certificate No: **EX3-3677_Nov10**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN:3677**

Calibration procedure(s) **QA CAL-01.v6, QA CAL-14.v3, QA CAL-23.v3 and QA CAL-25.v2
Calibration procedure for dosimetric E-field probes**

Calibration date: **November 24, 2010**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41495277	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41498097	1-Apr-10 (No. 217-01136)	Apr-11
Reference 3 dB Attenuator	SN: S5054 (3c)	30-Mar-10 (No. 217-01159)	Mar-11
Reference 20 dB Attenuator	SN: S5086 (20b)	30-Mar-10 (No. 217-01161)	Mar-11
Reference 30 dB Attenuator	SN: S5129 (30b)	30-Mar-10 (No. 217-01160)	Mar-11
Reference Probe ES3DV2	SN: 3013	30-Dec-09 (No. ES3-3013_Dec09)	Dec-10
DAE4	SN: 660	20-Apr-10 (No. DAE4-660_Apr10)	Apr-11
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-10)	In house check: Oct-11

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	
Approved by:	Niels Kuster	Quality Manager	

Issued: November 25, 2010.

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}:** Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(*f*)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}:** A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

EX3DV4 SN:3677

November 24, 2010

Probe EX3DV4

SN:3677

Manufactured:	September 9, 2008
Last calibrated:	September 23, 2009
Recalibrated:	November 24, 2010

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd. Test Report

EX3DV4 SN:3677

November 24, 2010

DASY/EASY - Parameters of Probe: EX3DV4 SN:3677

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.41	0.47	0.39	± 10.1%
DCP (mV) ^B	96.8	98.9	98.8	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc ^C (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	143.2	± 2.4 %
			Y	0.00	0.00	1.00	140.9	
			Z	0.00	0.00	1.00	135.8	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX, Y, Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^C Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EX3DV4 SN:3677

November 24, 2010

DASY/EASY - Parameters of Probe: EX3DV4 SN:3677

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
450	± 50 / ± 100	43.5 ± 5%	0.87 ± 5%	10.04	10.04	10.04	0.09	1.00 ± 13.3%
835	± 50 / ± 100	41.5 ± 5%	0.90 ± 5%	9.50	9.50	9.50	0.72	0.64 ± 11.0%
1750	± 50 / ± 100	40.1 ± 5%	1.37 ± 5%	8.22	8.22	8.22	0.72	0.59 ± 11.0%
1900	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	7.94	7.94	7.94	0.81	0.57 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	7.32	7.32	7.32	0.47	0.75 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

EX3DV4 SN:3677

November 24, 2010

DASY/EASY - Parameters of Probe: EX3DV4 SN:3677

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
450	± 50 / ± 100	56.7 ± 5%	0.94 ± 5%	10.62	10.62	10.62	0.02	1.00 ± 13.3%
750	± 50 / ± 100	55.5 ± 5%	0.96 ± 5%	10.14	10.14	10.14	0.59	0.72 ± 11.0%
835	± 50 / ± 100	55.2 ± 5%	0.97 ± 5%	10.33	10.33	10.33	0.20	2.06 ± 11.0%
1450	± 50 / ± 100	54.0 ± 5%	1.30 ± 5%	8.47	8.47	8.47	0.99	0.53 ± 11.0%
1750	± 50 / ± 100	53.4 ± 5%	1.49 ± 5%	8.02	8.02	8.02	0.63	0.67 ± 11.0%
1900	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	7.77	7.77	7.77	0.69	0.67 ± 11.0%
2100	± 50 / ± 100	53.2 ± 5%	1.62 ± 5%	8.04	8.04	8.04	0.16	1.44 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	7.46	7.46	7.46	0.99	0.49 ± 11.0%
3500	± 50 / ± 100	51.3 ± 5%	3.31 ± 5%	6.61	6.61	6.61	0.28	1.40 ± 13.1%

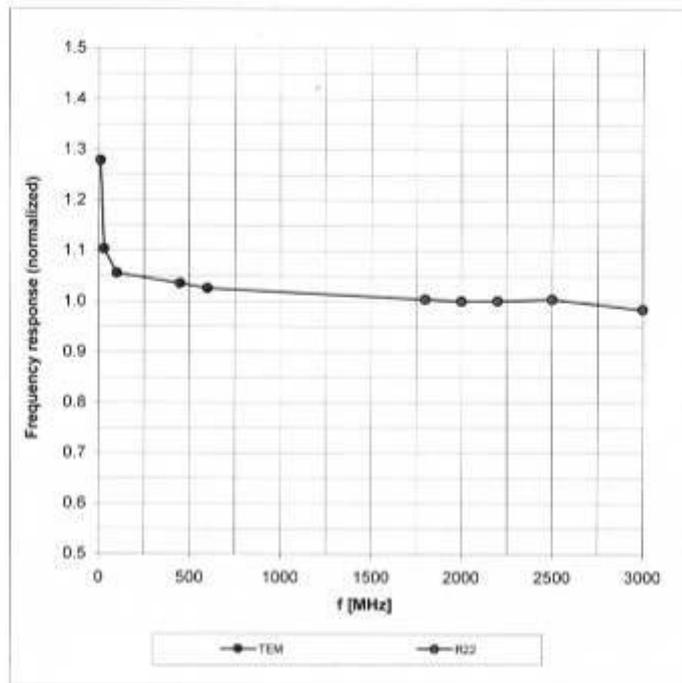
^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

EX3DV4 SN:3677

November 24, 2010

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)

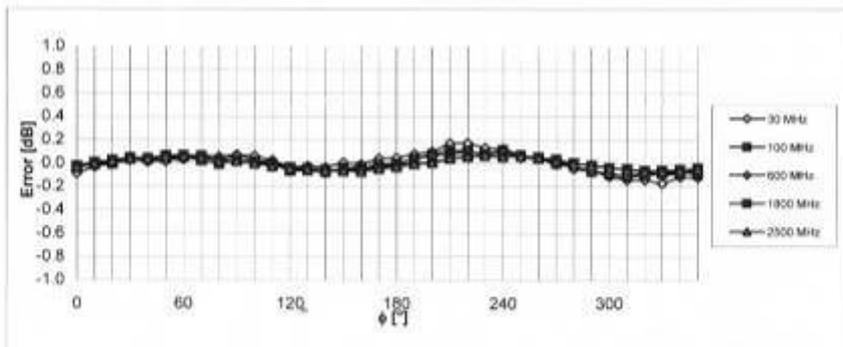
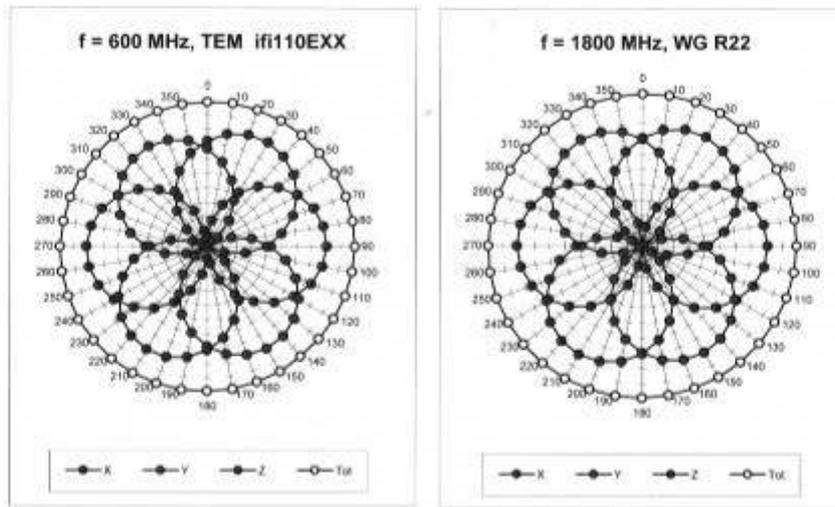


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

EX3DV4 SN:3677

November 24, 2010

Receiving Pattern (ϕ), $\vartheta = 0^\circ$

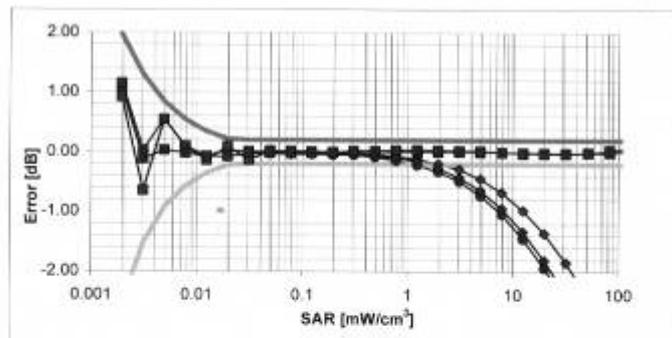
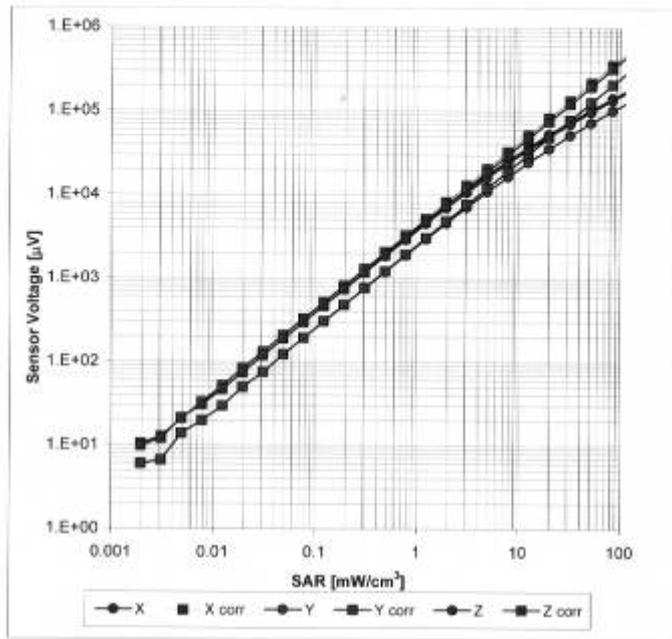


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

EX3DV4 SN:3677

November 24, 2010

Dynamic Range f(SAR_{head})
(TEM cell, f = 900 MHz)

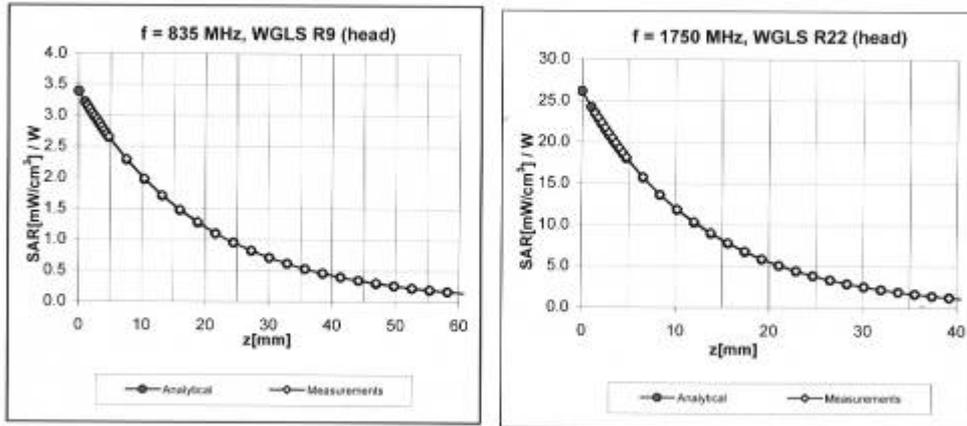


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

EX3DV4 SN:3677

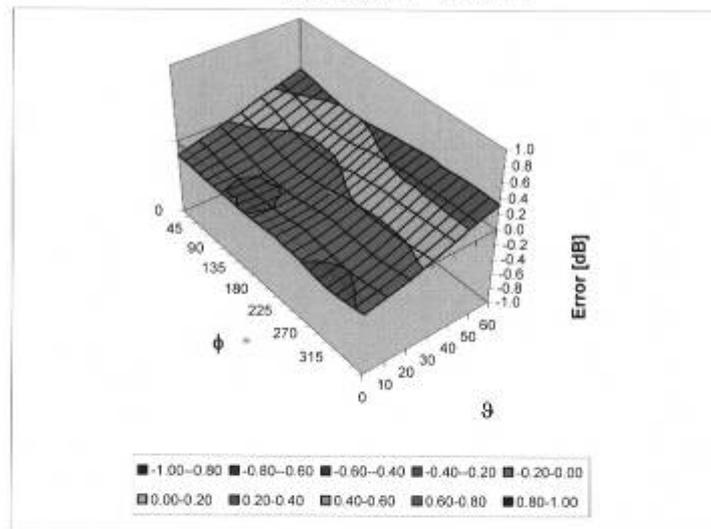
November 24, 2010

Conversion Factor Assessment



Deviation from Isotropy in HSL

Error (ϕ , θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)

TA Technology (Shanghai) Co., Ltd.
Test Report

EX3DV4 SN:3677

November 24, 2010

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	2 mm

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA1110-1724SAR01R1

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ANNEX E: D835V2 Dipole Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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S Servizio svizzero di taratura
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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA-Shanghai (Auden)**

Certificate No: **D835V2-4d020_Aug11**

CALIBRATION CERTIFICATE

Object: **D835V2 - SN: 4d020**

Calibration procedure(s): **QA CAL-05.v8
Calibration procedure for dipole validation kits above 700 MHz**

Calibration date: **August 26, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-10 (No. 217-01266)	Oct-11
Power sensor HP 8481A	US37292783	06-Oct-10 (No. 217-01266)	Oct-11
Reference 20 dB Attenuator	SN: S5086 (20b)	29-Mar-11 (No. 217-01367)	Apr-12
Type-N mismatch combination	SN: 5047.2 / 06327	29-Mar-11 (No. 217-01371)	Apr-12
Reference Probe ES3DV3	SN: 3205	29-Apr-11 (No. ES3-3205_Apr11)	Apr-12
DAE4	SN: 601	04-Jul-11 (No. DAE4-601_Jul11)	Jul-12
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
RF generator R&S SMT-06	100005	04-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-10)	In house check: Oct-11

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: August 26, 2011

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TA Technology (Shanghai) Co., Ltd.

Test Report

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**Calibration Laboratory of
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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

TA Technology (Shanghai) Co., Ltd. Test Report

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.1 ± 6 %	0.89 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.32 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	9.34 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.52 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	6.11 mW / g ± 16.5 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.2	0.97 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	53.4 ± 6 %	0.99 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.42 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	9.46 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	1.59 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	6.26 mW / g ± 16.5 % (k=2)

TA Technology (Shanghai) Co., Ltd.

Test Report

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	52.9 Ω - 3.1 $j\Omega$
Return Loss	- 27.7 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	48.7 Ω - 5.4 $j\Omega$
Return Loss	- 25.1 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.391 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	April 22, 2004

DASY5 Validation Report for Head TSL

Date: 25.08.2011

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Communication System: CW; Frequency: 835 MHz

Medium parameters used: $f = 835$ MHz; $\sigma = 0.89$ mho/m; $\epsilon_r = 41.1$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(6.07, 6.07, 6.07); Calibrated: 29.04.2011
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

Dipole Calibration for Head Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:

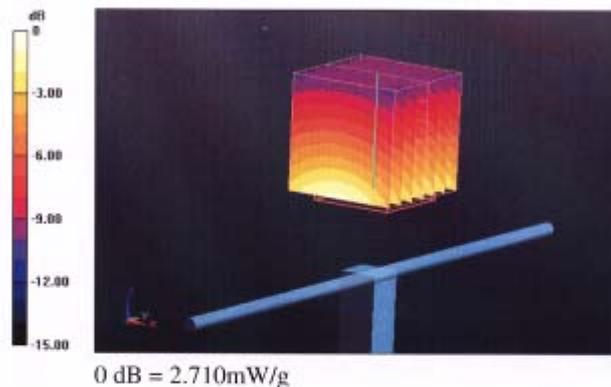
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 56.930 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 3.421 W/kg

SAR(1 g) = 2.32 mW/g; SAR(10 g) = 1.52 mW/g

Maximum value of SAR (measured) = 2.708 mW/g

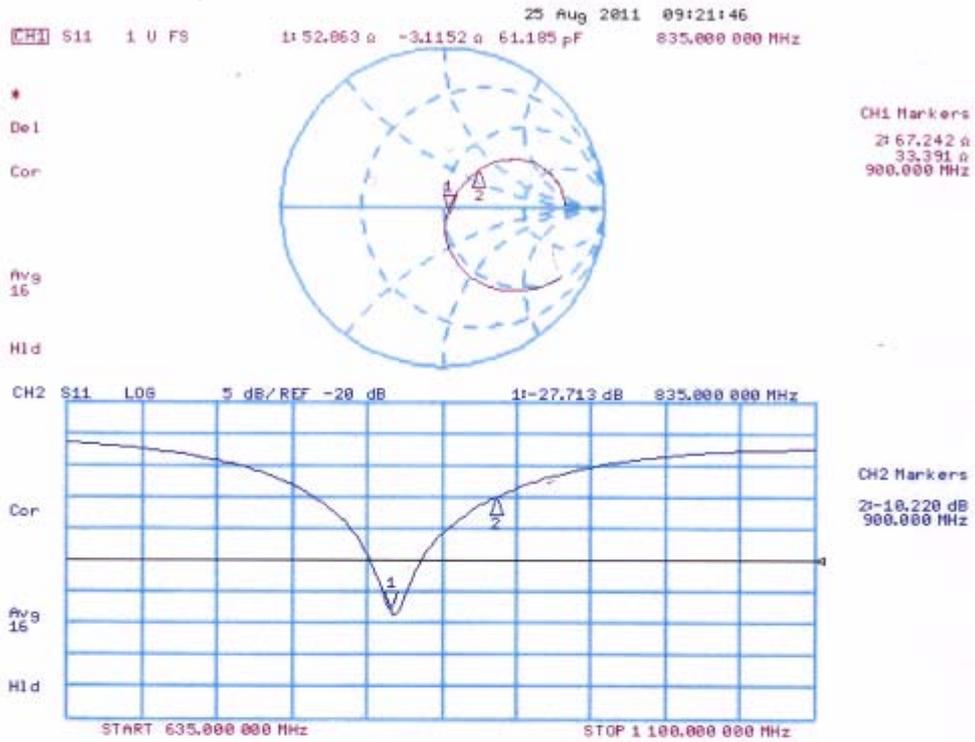


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Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date: 26.08.2011

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Communication System: CW; Frequency: 835 MHz

Medium parameters used: $f = 835$ MHz; $\sigma = 0.99$ mho/m; $\epsilon_r = 53.4$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(6.02, 6.02, 6.02); Calibrated: 29.04.2011
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

Dipole Calibration for Body Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:

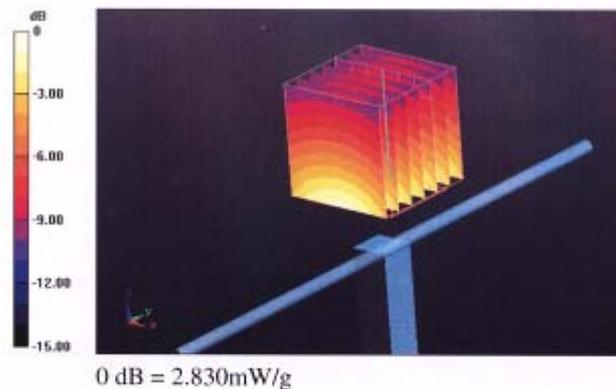
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.406 V/m; Power Drift = 0.02 dB

Peak SAR (extrapolated) = 3.509 W/kg

SAR(1 g) = 2.42 mW/g; SAR(10 g) = 1.59 mW/g

Maximum value of SAR (measured) = 2.827 mW/g

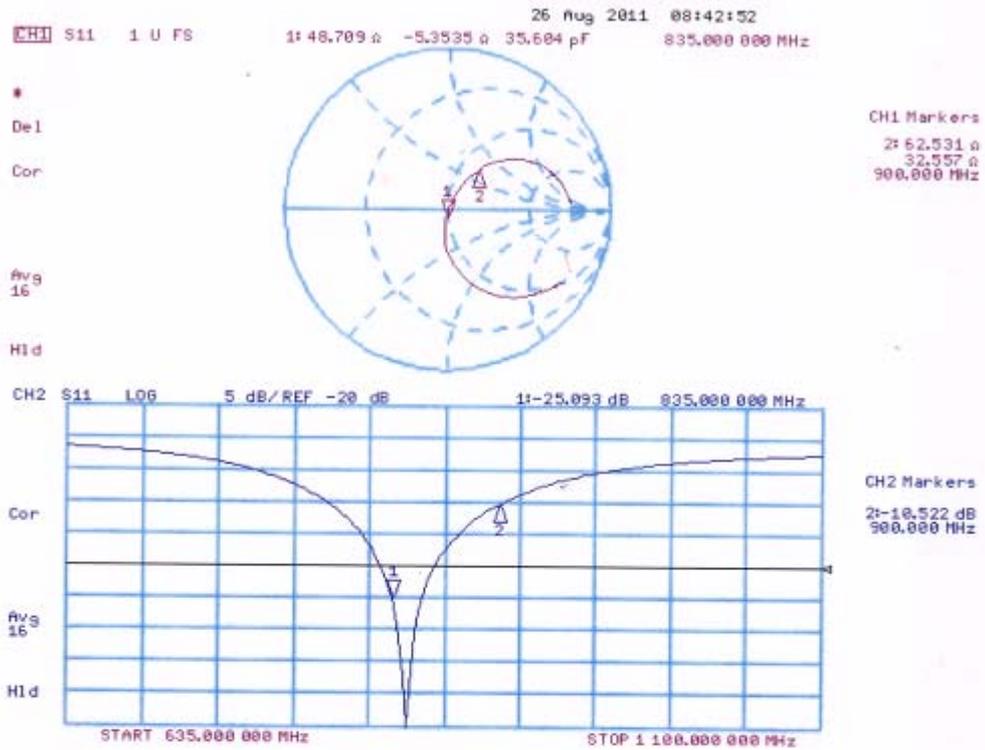


TA Technology (Shanghai) Co., Ltd. Test Report

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Impedance Measurement Plot for Body TSL



TA Technology (Shanghai) Co., Ltd. Test Report

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ANNEX F: D1900V2 Dipole Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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Accreditation No.: **SCS 108**

Client **TA-Shanghai (Auden)**

Certificate No: **D1900V2-5d060_Aug11**

CALIBRATION CERTIFICATE																																															
Object	D1900V2 - SN: 5d060																																														
Calibration procedure(s)	QA CAL-05.v8 Calibration procedure for dipole validation kits above 700 MHz																																														
Calibration date:	August 31, 2011																																														
<p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.</p> <p>Calibration Equipment used (M&TE critical for calibration)</p> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="width: 30%;">Primary Standards</th> <th style="width: 15%;">ID #</th> <th style="width: 30%;">Cal Date (Certificate No.)</th> <th style="width: 25%;">Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Power meter EPM-442A</td> <td>GB37480704</td> <td>06-Oct-10 (No. 217-01266)</td> <td>Oct-11</td> </tr> <tr> <td>Power sensor HP 8481A</td> <td>US37292783</td> <td>06-Oct-10 (No. 217-01266)</td> <td>Oct-11</td> </tr> <tr> <td>Reference 20 dB Attenuator</td> <td>SN: S5086 (20b)</td> <td>29-Mar-11 (No. 217-01367)</td> <td>Apr-12</td> </tr> <tr> <td>Type-N mismatch combination</td> <td>SN: 5047.2 / 06327</td> <td>29-Mar-11 (No. 217-01371)</td> <td>Apr-12</td> </tr> <tr> <td>Reference Probe ES3DV3</td> <td>SN: 3205</td> <td>29-Apr-11 (No. ES3-3205_Apr11)</td> <td>Apr-12</td> </tr> <tr> <td>DAE4</td> <td>SN: 601</td> <td>04-Jul-11 (No. DAE4-601_Jul11)</td> <td>Jul-12</td> </tr> </tbody> </table> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="width: 30%;">Secondary Standards</th> <th style="width: 15%;">ID #</th> <th style="width: 30%;">Check Date (in house)</th> <th style="width: 25%;">Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>Power sensor HP 8481A</td> <td>MY41092317</td> <td>18-Oct-02 (in house check Oct-09)</td> <td>In house check: Oct-11</td> </tr> <tr> <td>RF generator R&S SMT-06</td> <td>100005</td> <td>04-Aug-99 (in house check Oct-09)</td> <td>In house check: Oct-11</td> </tr> <tr> <td>Network Analyzer HP 8753E</td> <td>US37390585 S4206</td> <td>18-Oct-01 (in house check Oct-10)</td> <td>In house check: Oct-11</td> </tr> </tbody> </table>				Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	Power meter EPM-442A	GB37480704	06-Oct-10 (No. 217-01266)	Oct-11	Power sensor HP 8481A	US37292783	06-Oct-10 (No. 217-01266)	Oct-11	Reference 20 dB Attenuator	SN: S5086 (20b)	29-Mar-11 (No. 217-01367)	Apr-12	Type-N mismatch combination	SN: 5047.2 / 06327	29-Mar-11 (No. 217-01371)	Apr-12	Reference Probe ES3DV3	SN: 3205	29-Apr-11 (No. ES3-3205_Apr11)	Apr-12	DAE4	SN: 601	04-Jul-11 (No. DAE4-601_Jul11)	Jul-12	Secondary Standards	ID #	Check Date (in house)	Scheduled Check	Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11	RF generator R&S SMT-06	100005	04-Aug-99 (in house check Oct-09)	In house check: Oct-11	Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-10)	In house check: Oct-11
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Calibrated by:	Name Dimce Iliev	Function Laboratory Technician	Signature 																																												
Approved by:	Name Katja Pokovic	Technical Manager																																													
Issued: August 31, 2011																																															
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Test Report

Report No. RZA1110-1724SAR01R1

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Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

TA Technology (Shanghai) Co., Ltd. Test Report

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.5 ± 6 %	1.42 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	10.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	40.3 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.30 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	21.1 mW / g ± 16.5 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	53.9 ± 6 %	1.57 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	10.6 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	41.7 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	5.55 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	22.0 mW / g ± 16.5 % (k=2)

TA Technology (Shanghai) Co., Ltd.

Test Report

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	52.6 Ω + 7.5 j Ω
Return Loss	- 22.3 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	47.3 Ω + 7.9 j Ω
Return Loss	- 21.3 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.194 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	December 10, 2004

DASY5 Validation Report for Head TSL

Date: 30.08.2011

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN: 5d060

Communication System: CW; Frequency: 1900 MHz

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.42$ mho/m; $\epsilon_r = 39.5$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(5.01, 5.01, 5.01); Calibrated: 29.04.2011
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

Dipole Calibration for Head Tissue/Pin=250 mW, d=10mm/Zoom Scan (7x7x7)/Cube 0:

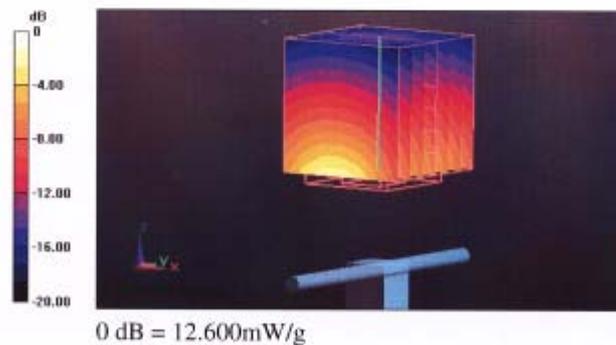
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 97.636 V/m; Power Drift = 0.07 dB

Peak SAR (extrapolated) = 18.535 W/kg

SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.3 mW/g

Maximum value of SAR (measured) = 12.600 mW/g

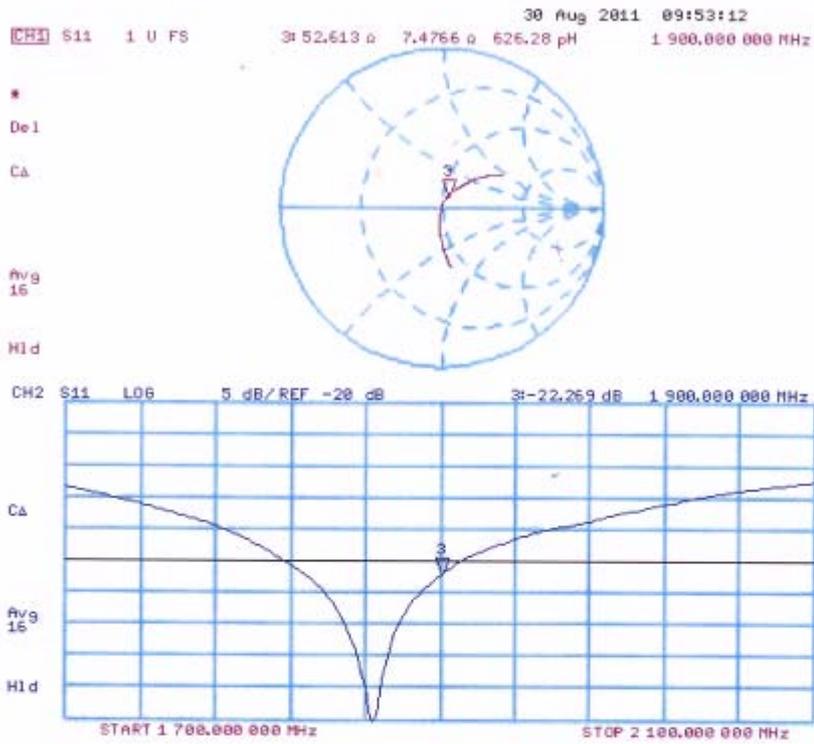


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Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date: 31.08.2011

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN: 5d060

Communication System: CW; Frequency: 1900 MHz

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.57$ mho/m; $\epsilon_r = 53.9$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(4.62, 4.62, 4.62); Calibrated: 29.04.2011
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

Dipole Calibration for Body Tissue/Pin=250 mW, d=10mm/Zoom Scan (7x7x7)/Cube 0:

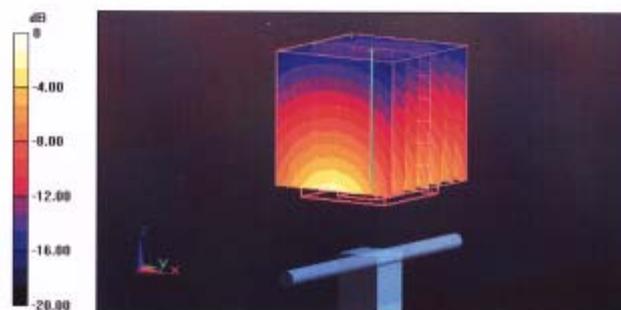
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 96.435 V/m; Power Drift = -0.0099 dB

Peak SAR (extrapolated) = 18.663 W/kg

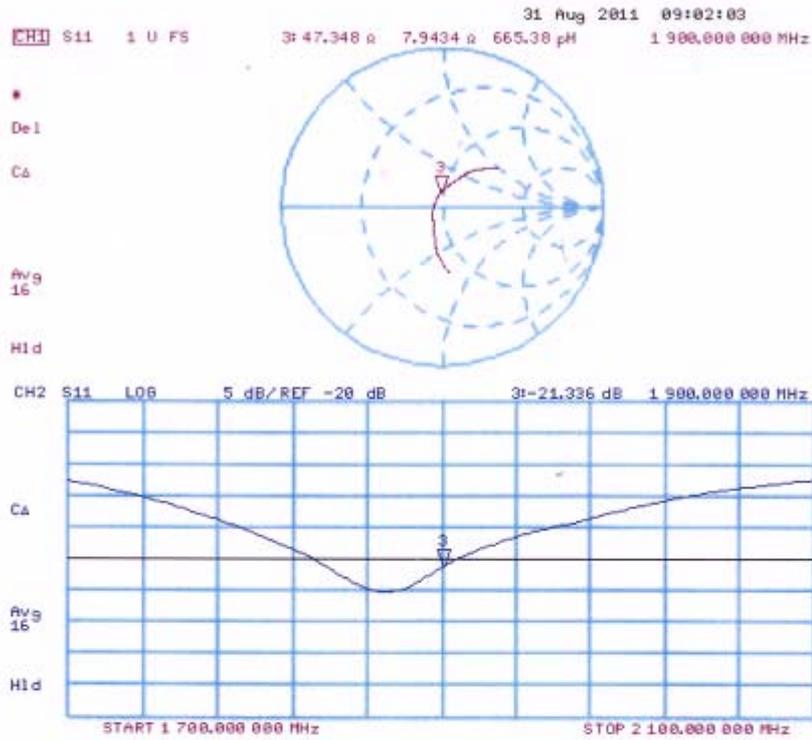
SAR(1 g) = 10.6 mW/g; SAR(10 g) = 5.55 mW/g

Maximum value of SAR (measured) = 13.397 mW/g



0 dB = 13.400mW/g

Impedance Measurement Plot for Body TSL



TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA1110-1724SAR01R1

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ANNEX G: DAE4 Calibration Certificate

**Calibration Laboratory of
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Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Client **TA - SH (Auden)**

Certificate No: **DAE4-871_Nov10**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 871**

Calibration procedure(s) **QA CAL-06.v22
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **November 18, 2010**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	26-Sep-10 (No.10376)	Sep-11
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	07-Jun-10 (in house check)	In house check: Jun-11

Calibrated by:	Name Andrea Guntli	Function Technician	Signature
Approved by:	Name Fin Bornholt	Function R&D Director	Signature

Issued: November 18, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

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Test Report

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV
Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.757 \pm 0.1% (k=2)	404.740 \pm 0.1% (k=2)	405.181 \pm 0.1% (k=2)
Low Range	3.98219 \pm 0.7% (k=2)	3.93489 \pm 0.7% (k=2)	3.96831 \pm 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	90.0 $^{\circ}$ \pm 1 $^{\circ}$
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Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200001.2	-1.56	-0.00
Channel X + Input	20000.71	0.71	0.00
Channel X - Input	-19997.87	1.63	-0.01
Channel Y + Input	199994.3	1.99	0.00
Channel Y + Input	19998.92	-1.08	-0.01
Channel Y - Input	-20000.26	-0.76	0.00
Channel Z + Input	200009.2	-1.04	-0.00
Channel Z + Input	19998.70	-1.10	-0.01
Channel Z - Input	-20000.16	-0.76	0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2000.1	0.16	0.01
Channel X + Input	199.58	-0.52	-0.26
Channel X - Input	-200.79	-0.89	0.45
Channel Y + Input	1999.9	-0.03	-0.00
Channel Y + Input	199.45	-0.55	-0.27
Channel Y - Input	-200.31	-0.41	0.21
Channel Z + Input	2000.1	0.33	0.02
Channel Z + Input	199.13	-0.77	-0.38
Channel Z - Input	-201.47	-1.37	0.69

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	14.25	12.86
	-200	-12.68	-14.21
Channel Y	200	-10.04	-10.39
	-200	9.20	9.17
Channel Z	200	-0.85	-1.40
	-200	-0.34	-0.31

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.85	0.69
Channel Y	200	2.41	-	2.73
Channel Z	200	2.54	0.73	-

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Test Report

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15920	15517
Channel Y	16171	16732
Channel Z	15803	16474

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.03	-2.35	0.86	0.43
Channel Y	-0.50	-1.49	-0.49	0.38
Channel Z	-0.92	-2.21	0.14	0.44

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (k Ω m)	Measuring (M Ω m)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

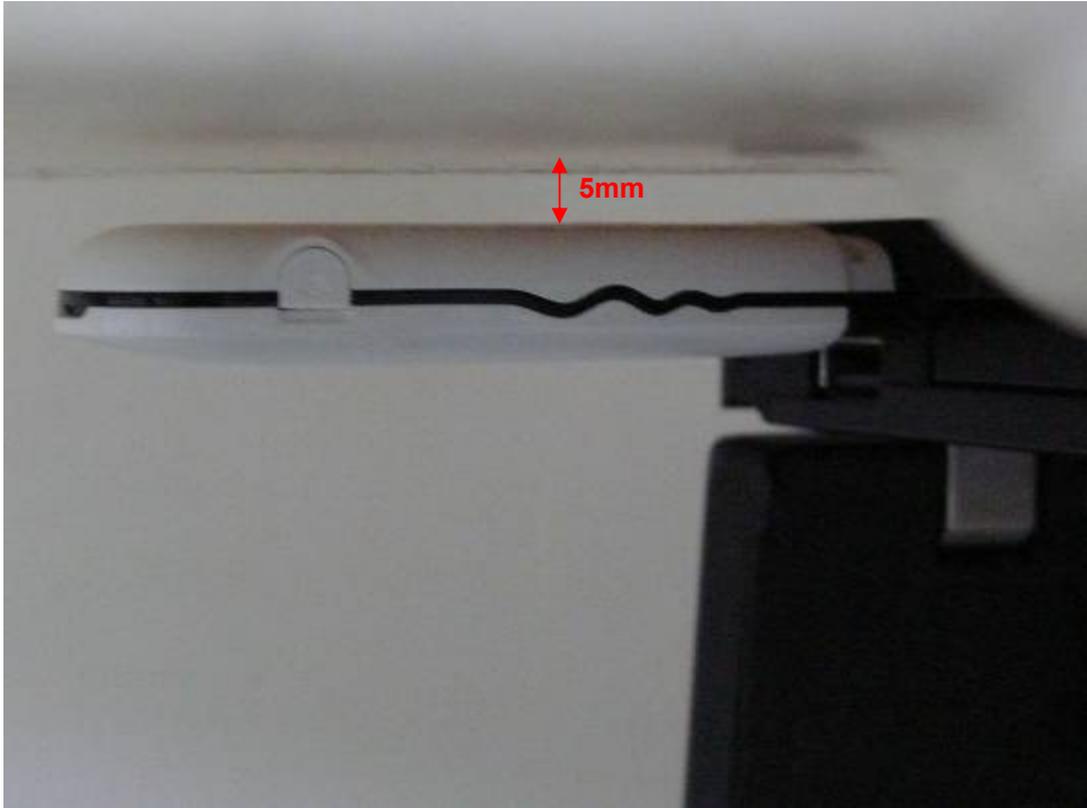
9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-8

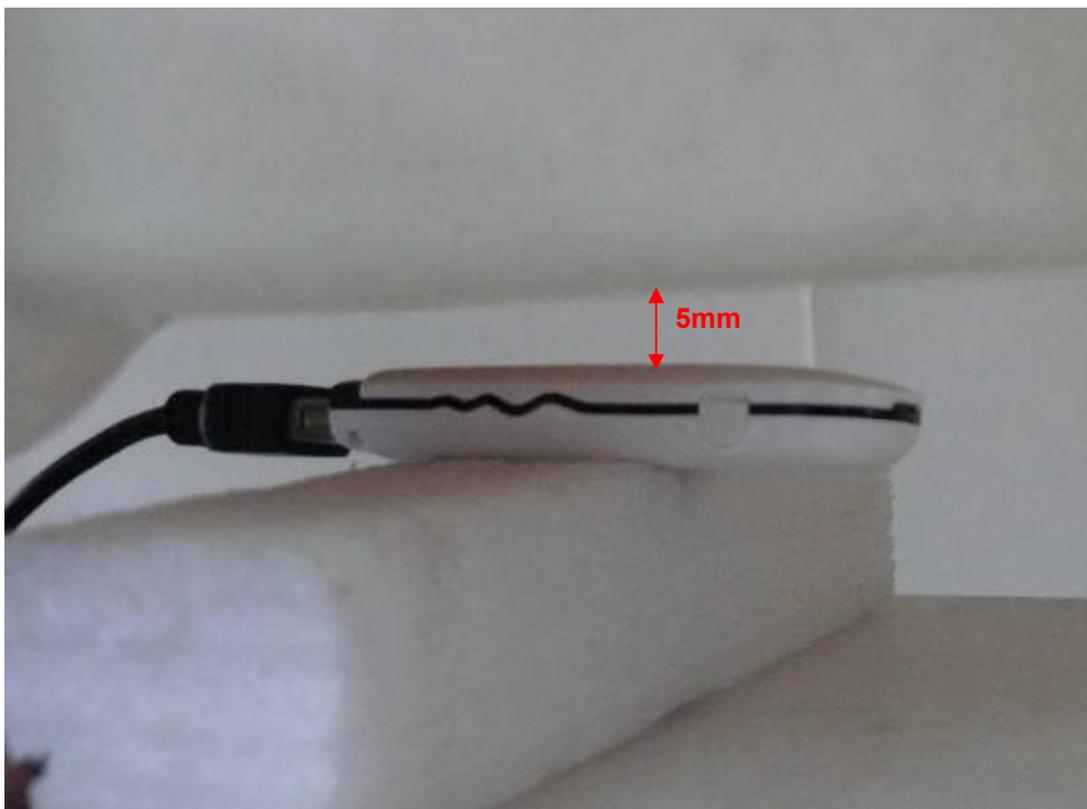
ANNEX H: The EUT Appearances and Test Configuration



Picture 5: Constituents of the EUT



Picture 6: Test position 1



Picture 7: Test position 2



Picture 8: Test Position 3



Picture 9: Test Position 4